

Penetrating Particle Analyser (PAN*). Silicon tracker development. Beamtest results

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On behalf of the PAN collaboration

*Penetrating Particle ANalyzer (PAN) X.Wu et al., Adv. Space Res. 63, 8, 2672-2682 (2019) <https://doi.org/10.1016/j.asr.2019.01.012>

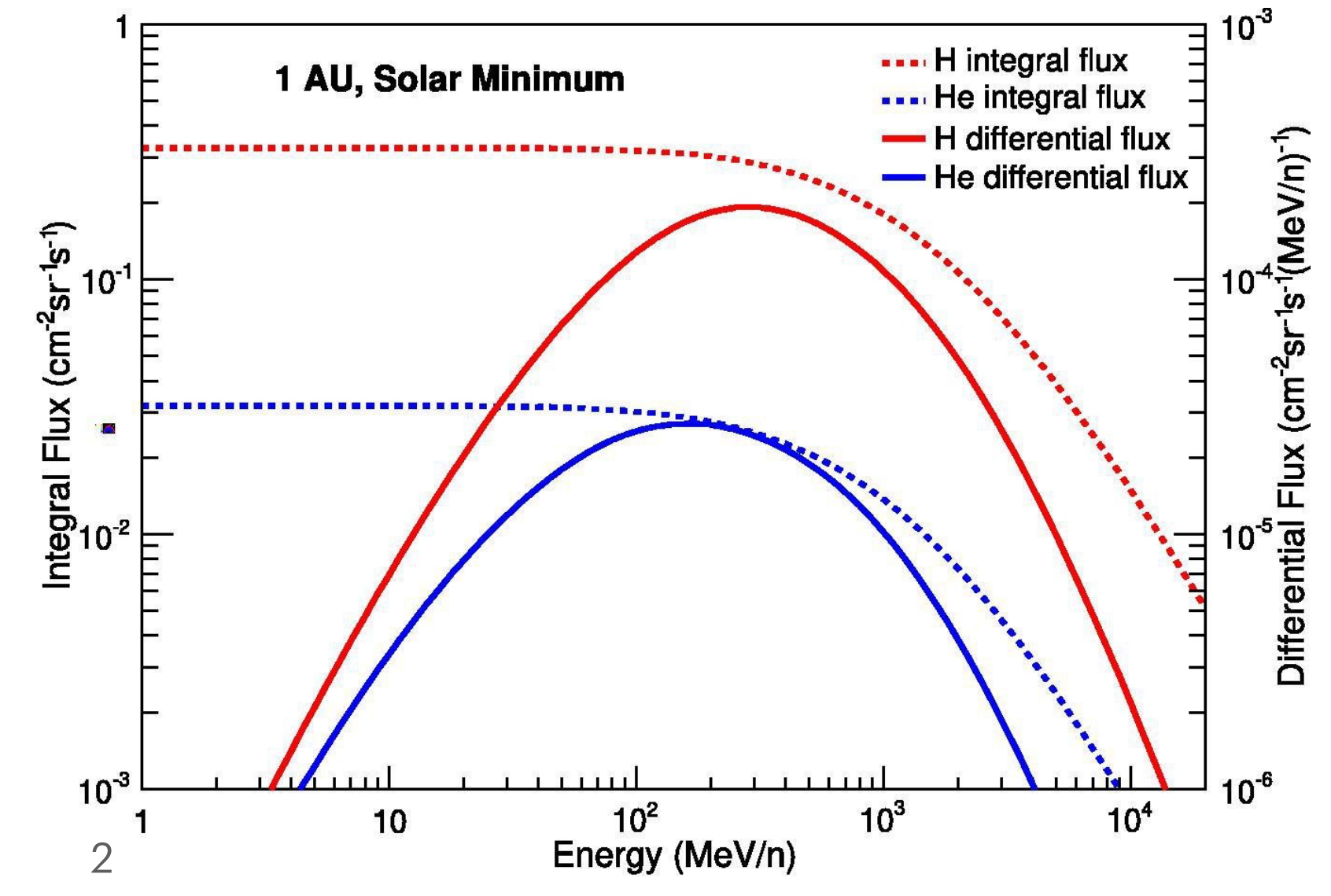
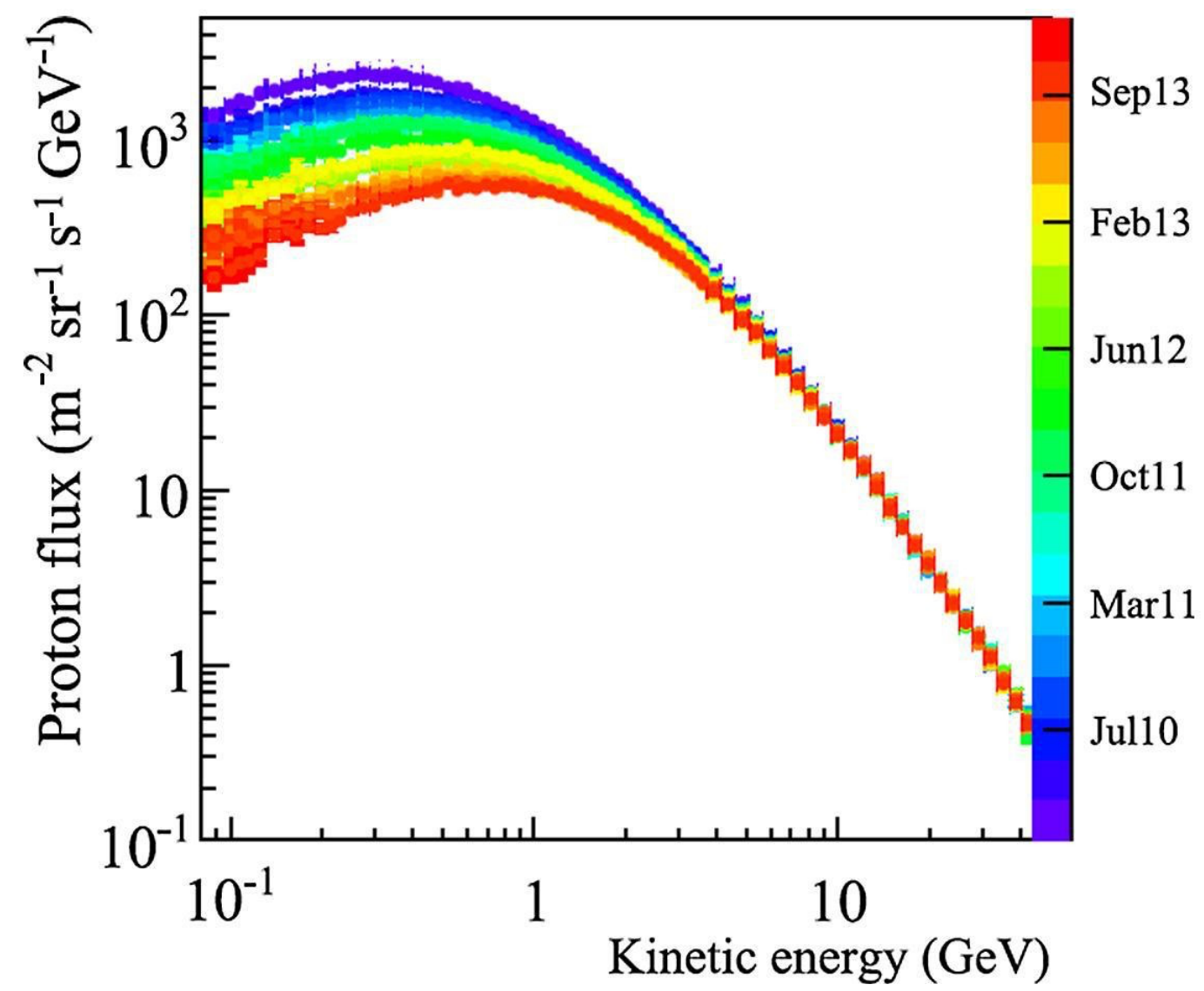
“Trento” Workshop 04.03.2022

PAN: enables precise penetrating particle detection in deep space!

PAN is a **generic instrument technology** for deep space and interplanetary missions

- Capable of precise measurement and monitoring in **real time** the flux, composition, direction of penetrating particles ($> \sim 100$ MeV/nucleon) in **deep space, around moons, planets, ...**
- $\sim 20\%$ energy resolution for proton at 1 GeV, “unprecedented” in deep space
- PAN fills a gap in observation and technology: **ground-breaking!**

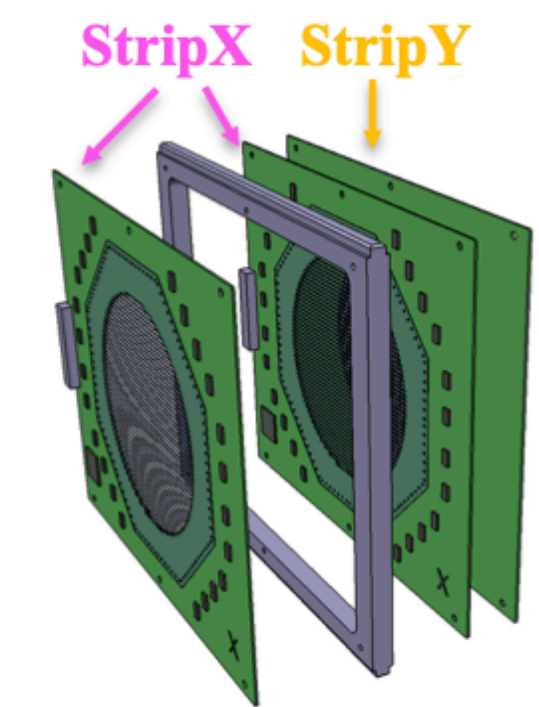
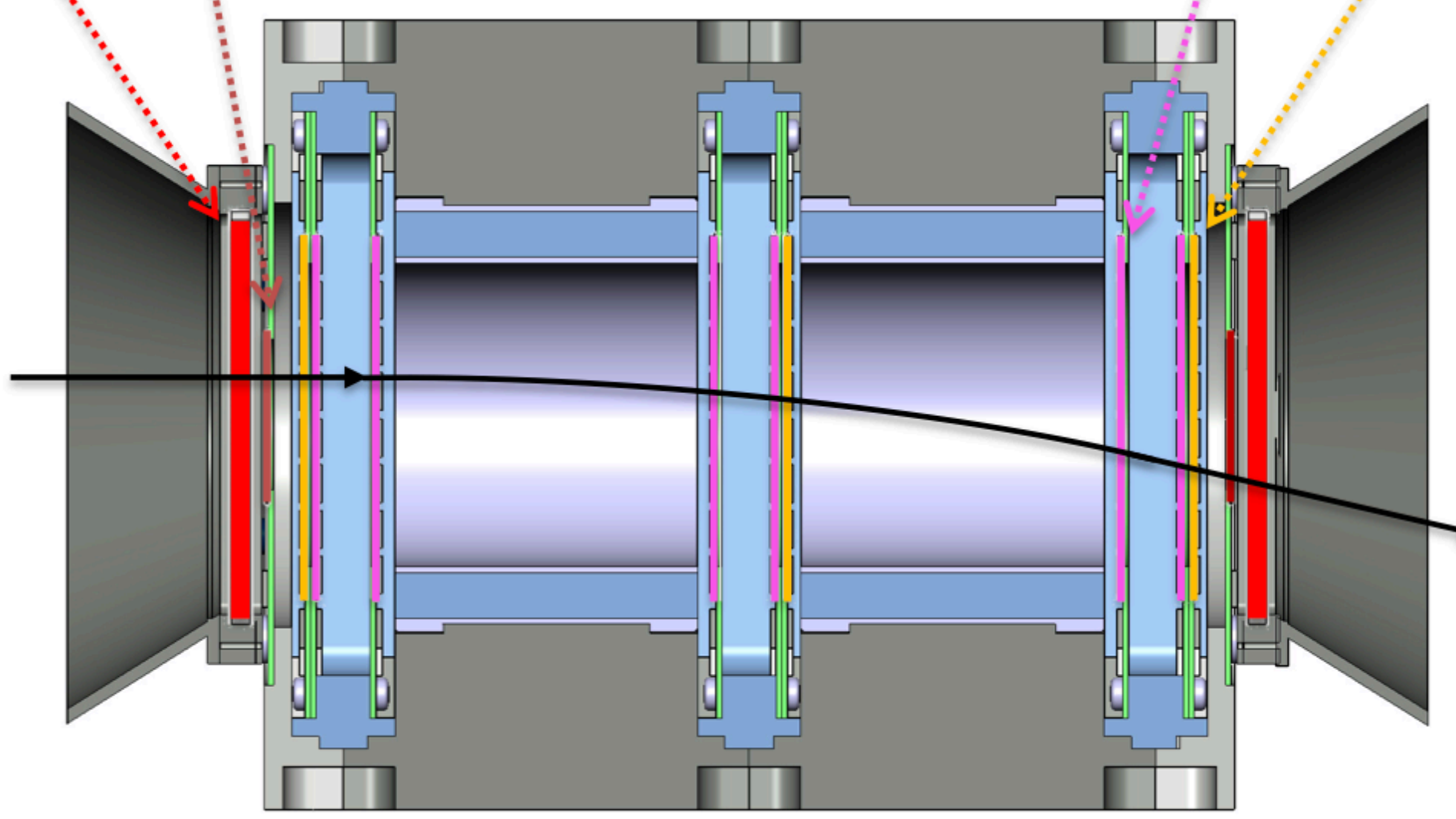
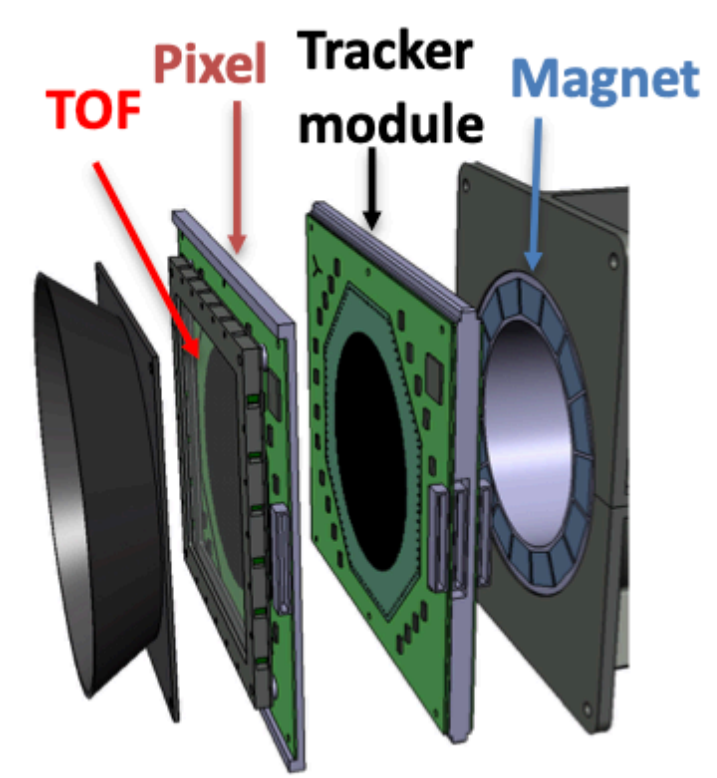
Evolution of proton spectra from the solar cycle 24 measured near Earth by PMAELA



Proton and Helium fluxes at 1 AU outside Earth's Magnetosphere. Calculation by SPENVIS toolkit

PAN: versatile integrated instrument concept

- Excellent rigidity resolution thanks to fine pitch thin (**StripX**, **StripY**) silicon detectors
- In addition: **TOF**, **PIXEL**

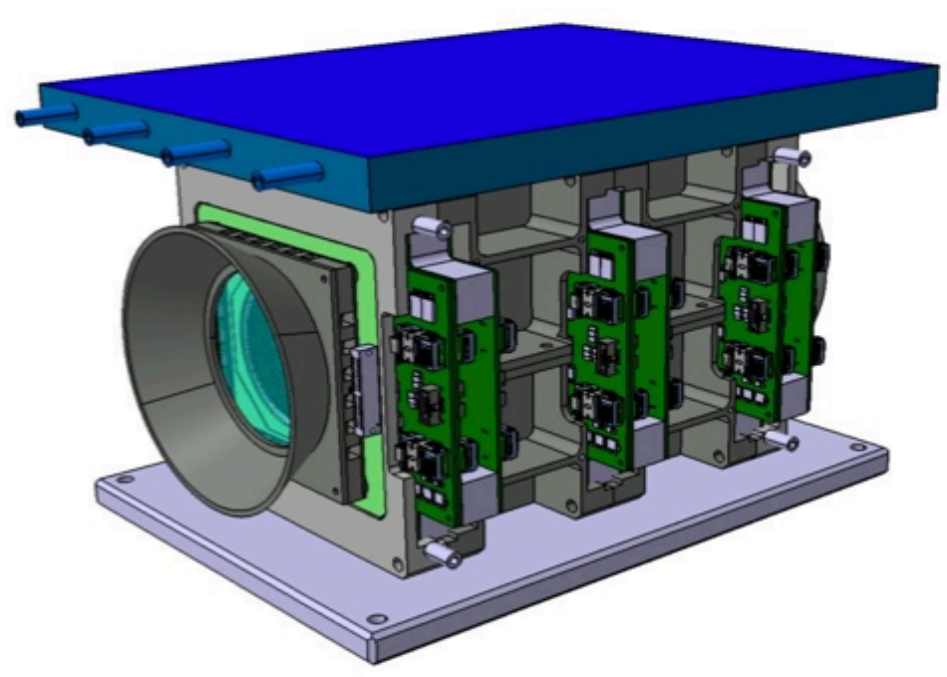


StripY: measure the particle direction in Y with an angular resolution $\sim 0.2^\circ$

- **TOF**: Plastic scintillator with SiPM readout
 - Provide a trigger
 - Measure Z
 - Measure **Time of Flight**
 - Provide a low energy particle counter

- Also provide trigger
- Measure Z (both Strip-X and Strip-Y)

- **PIXEL**: 3-d points with 55 μm Si pixels
 - **No measurement degradation even during the most intense solar storms**
 - **Provide a high rate particle counter**
 - Improve tracking (a fraction of events)
 - Measure Z (a fraction of events)
 - Only partial coverage for power saving



All the goodies for just <10 kg, < 30 W, 30 × 20 × 20 cm³ !!!

PAN Microstrip Silicon Sensors

1. Silicon Wafer **common** properties for both types of silicon strip detectors.

Device type	Single side AC-readout /double metal
Silicon Type	N-type, Phosphorus doped
Crystal orientation	<100>
Chip thickness	150±15 μm
Front and back side metal	AL
Full depletion voltage	Max. 50 V
Breakdown voltage	Min. 100 V
Tot. leakage current (at 1.5·V_depl)	max. 3 μA

3. Strip **Y** sensor properties.

Y sensor overall size	59000±20 x 59000±20 μm
Active area	Circular with D=51200 μm
Number of Strips	128 ch
Strip pitch	400 μm
Strip width	380 μm
Readout AL width	10 μm
Readout PAD pitch	91.2(2lines) μm

2. Strip **X** sensor properties.

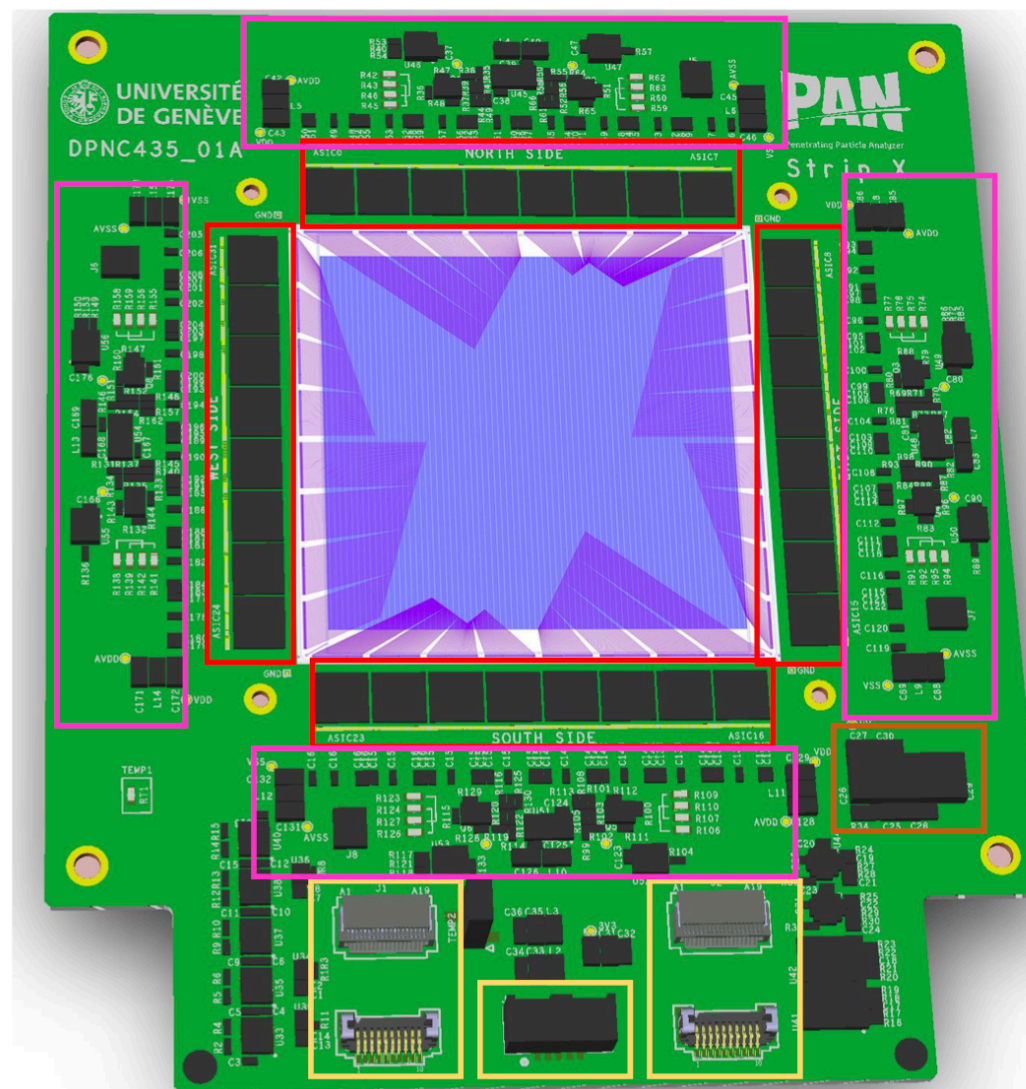
X sensor overall size	59000±20 x 59000±20 μm
Active area	51200 x 51200 μm
Number of Strips	2048 ch
Strip pitch	25 μm
Strip width	13 μm
Readout AL width	10 μm
Readout PAD pitch	96 μm

4x2 digitization chains

1x Hamamtsu sensor + routing

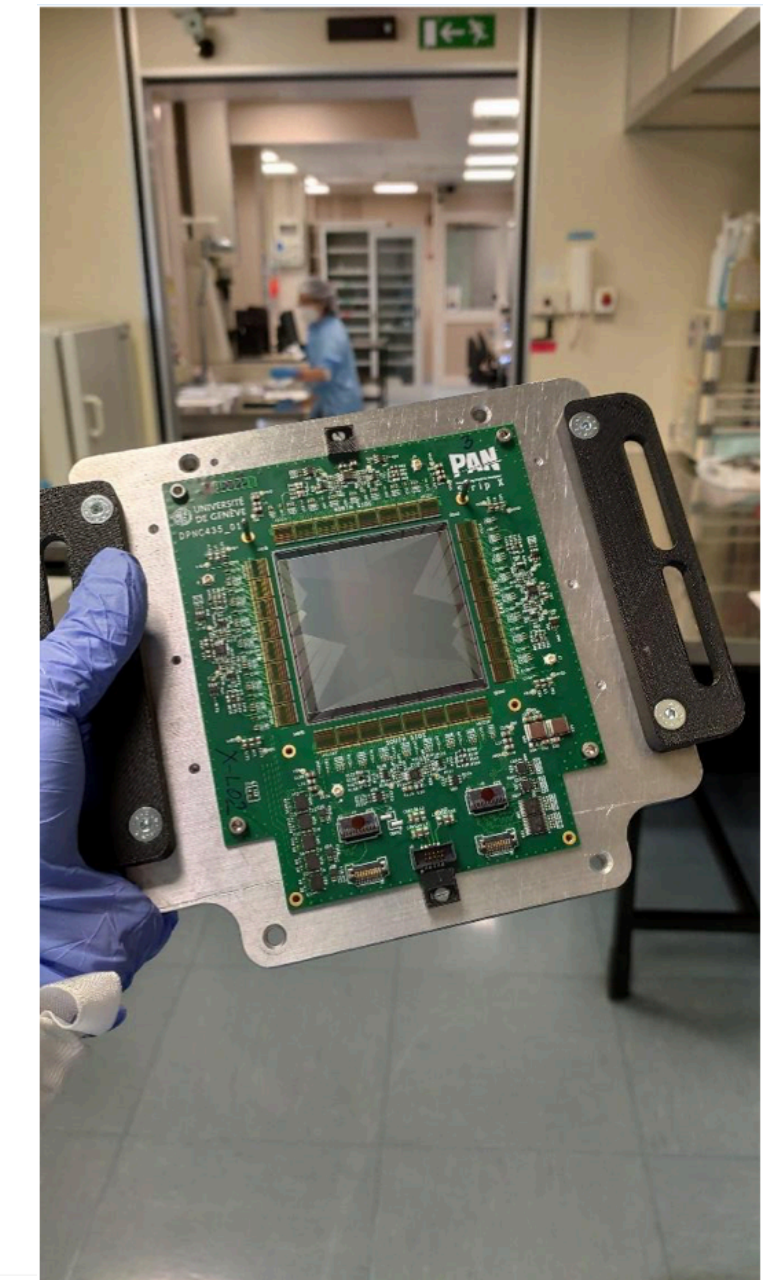
DAQ connectors

X – Detector Architecture



4x8 Ideas
IDE1140 VA

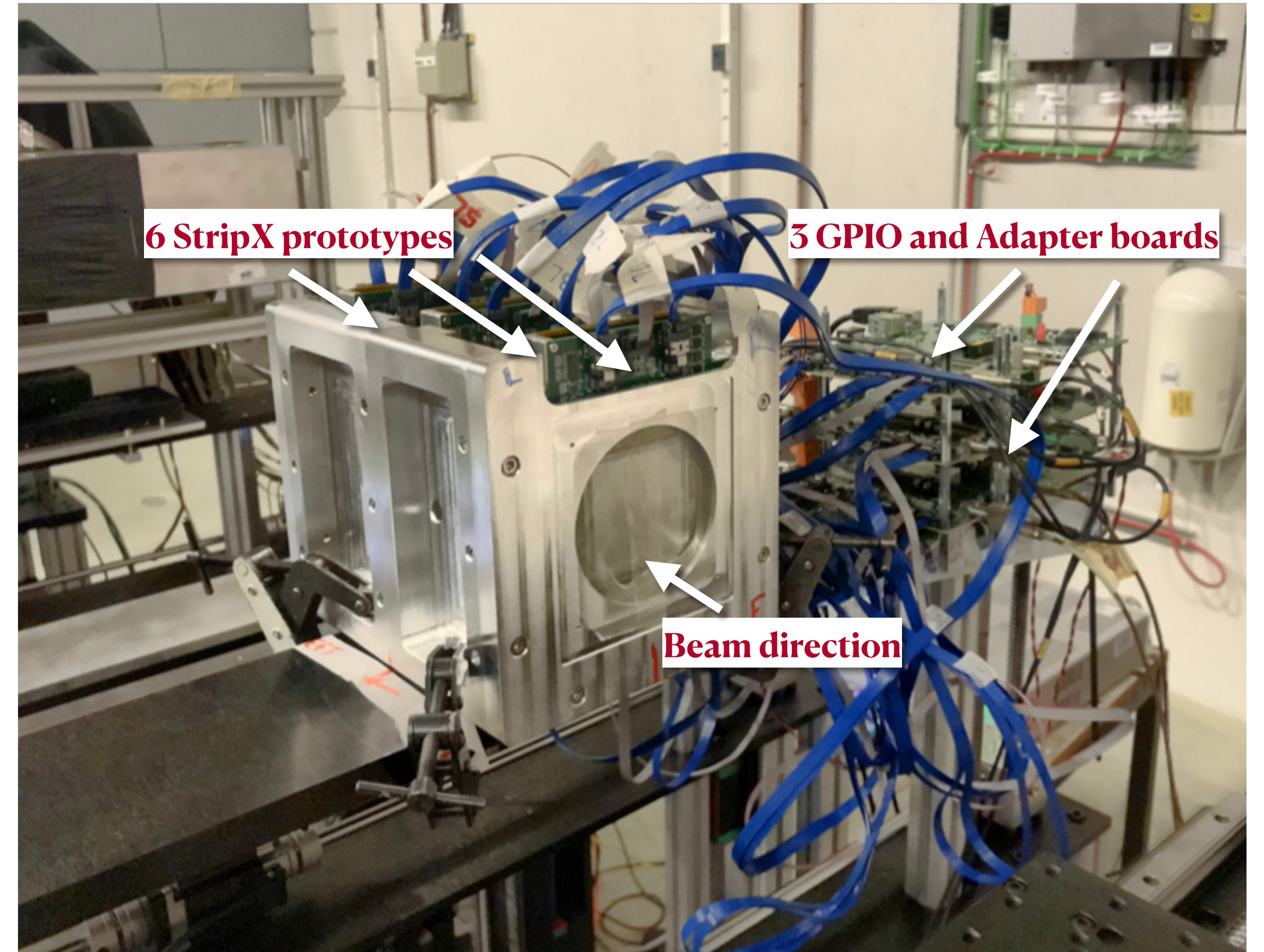
HV filters



Strip X Beam Test in November 2021

T9 beam line (CERN, East Area)

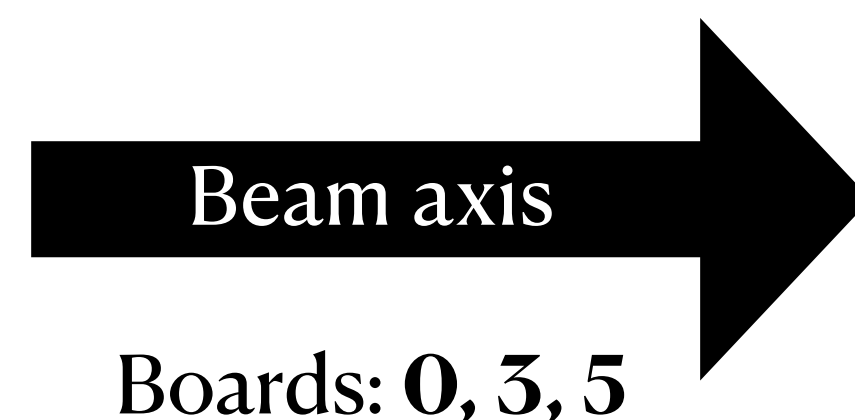
- **Objectives:**
 - Test the performance of **6 StripX** prototypes
 - Test the DAQ capability to readout **6 StripX** boards
 - Perform runs with/without magnets installed.



StripX detectors inside the experimental area of T9 beam line.

Beam and DAQ Parameters

- Beam parameters:
 - Particles: π^- .
 - Momentum: **10 GeV/c**.
 - H/V dimensions: **~1.0 cm FWHM**.
 - Beam trigger in coinc. with **2 Cherenkov detectors** for better energy resolution
- DAQ configuration:
 - StripX boards bias voltage: **40 V**.
 - **6 StripX** boards read by **3 GPIO** boards and **3 Adapter** boards connected to a PC through USB.
 - **GPIO software**: “socket” mode, controlled via a TCP connection.
 - **Visualisation** software: based on **ROOT**, controlling the GPIO software.
 - **Visualisation** software: starts a calibration, a normal DAQ, an offline analysis.

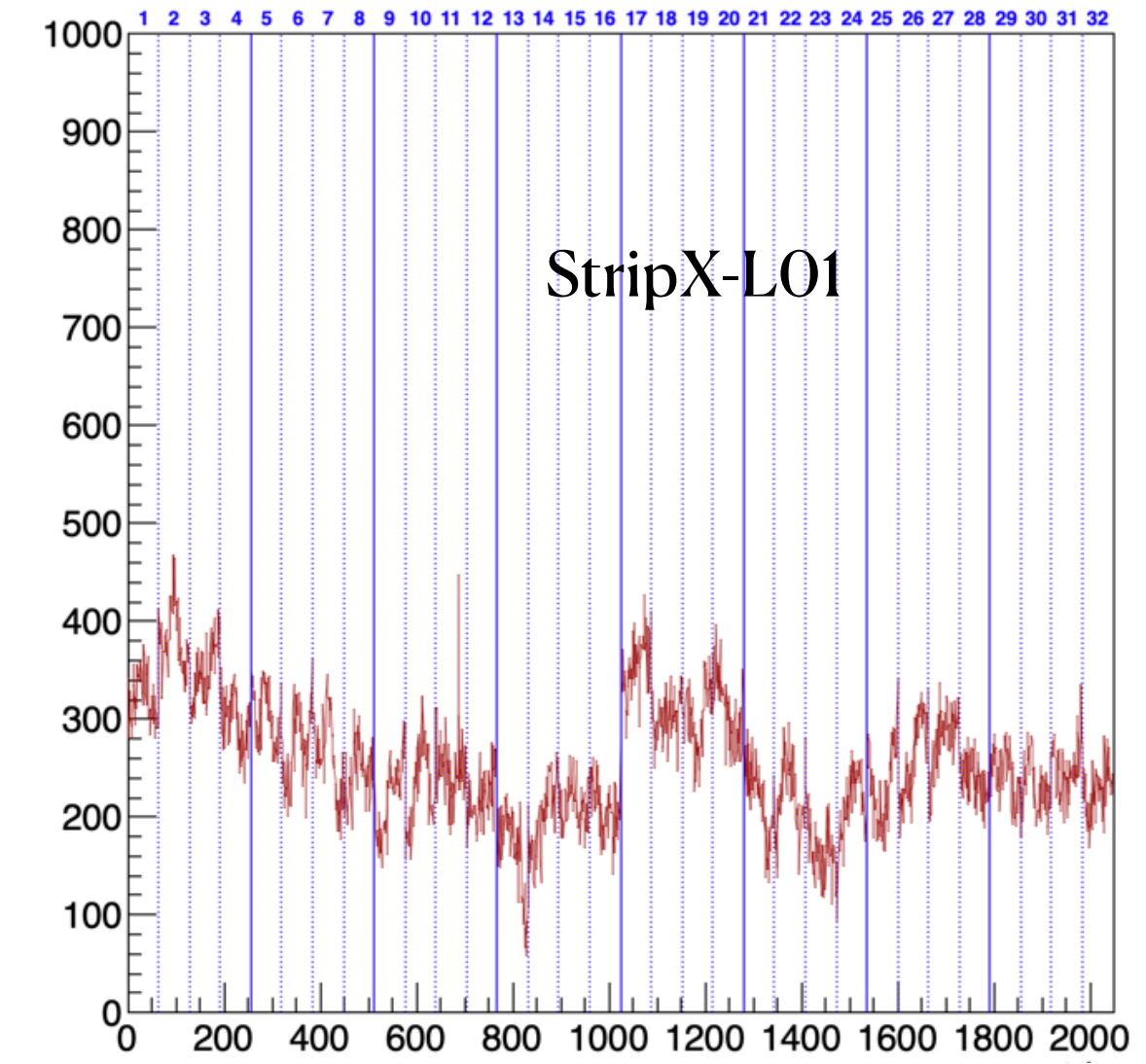


Board 0: StripX-L01 + StripX-L03

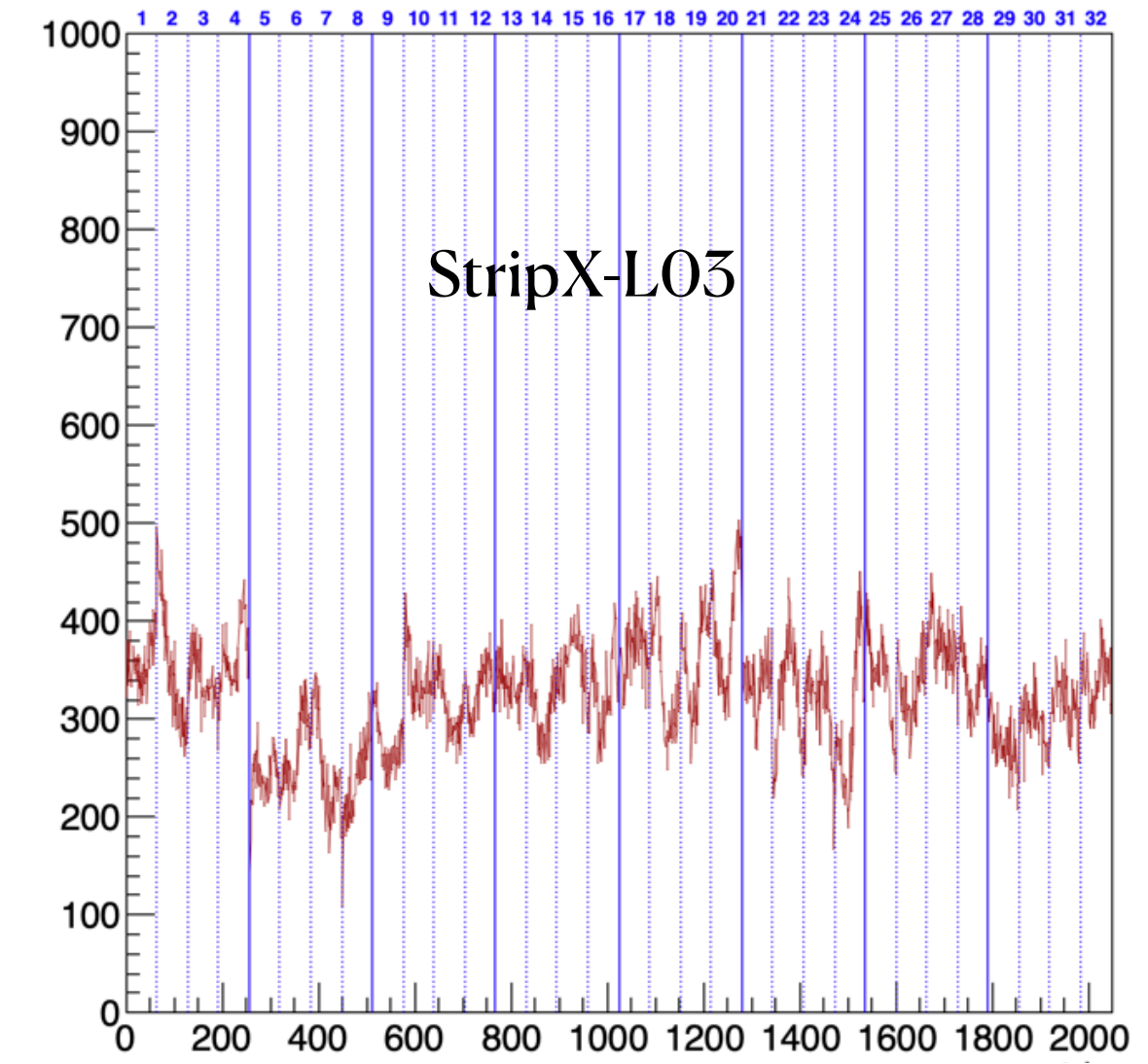
- Pedestals from a calibration run.

- Standard deviation of ADC values per channel from a calibration run (CN subtracted): **~1.5-2.5 ADC units.**

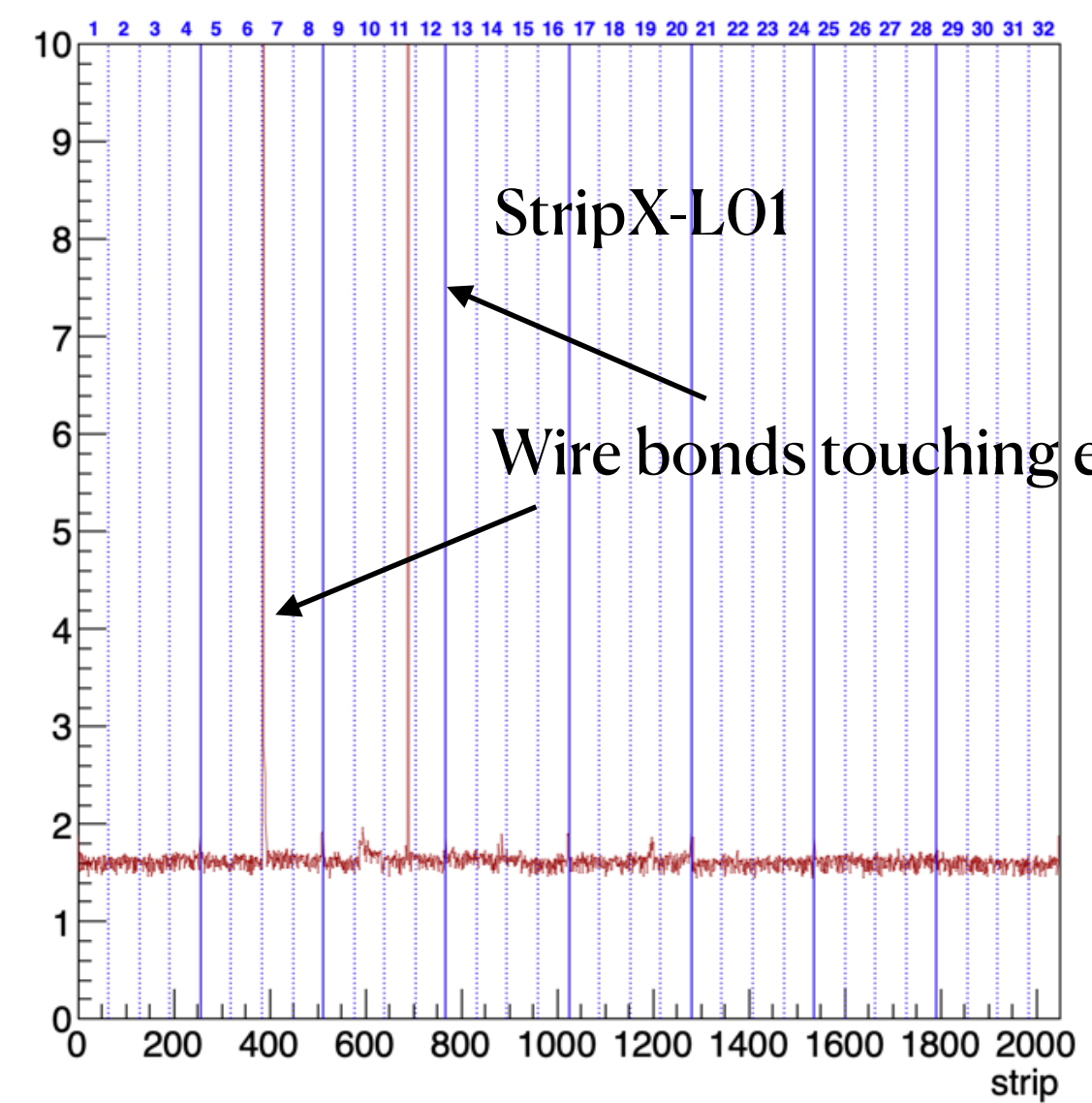
Pedestals - Ladder 0



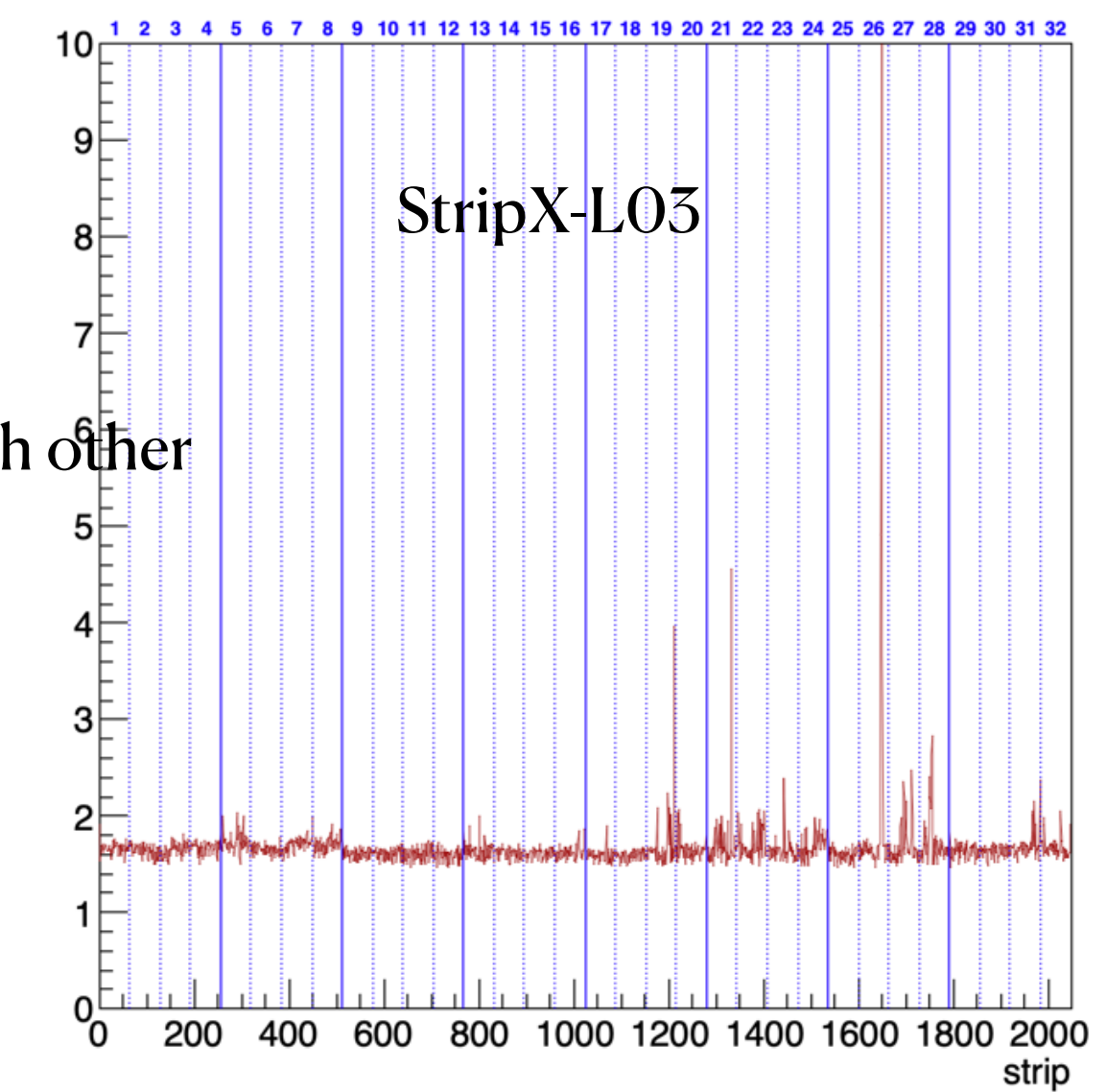
Pedestals - Ladder 1



Sigmas - Ladder 0



Sigmas - Ladder 1

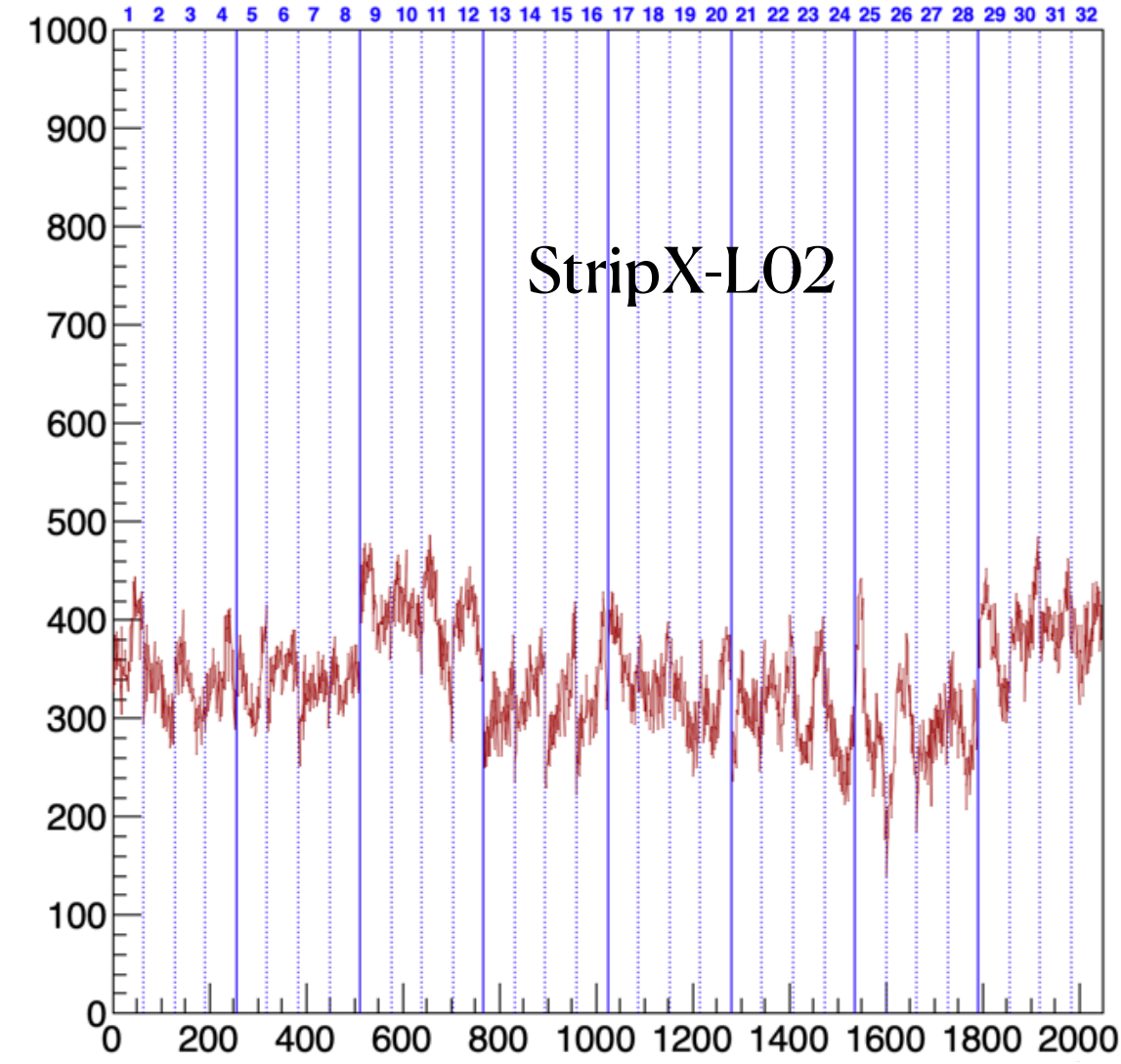


Board 3: StripX-L02+ StripX-L06

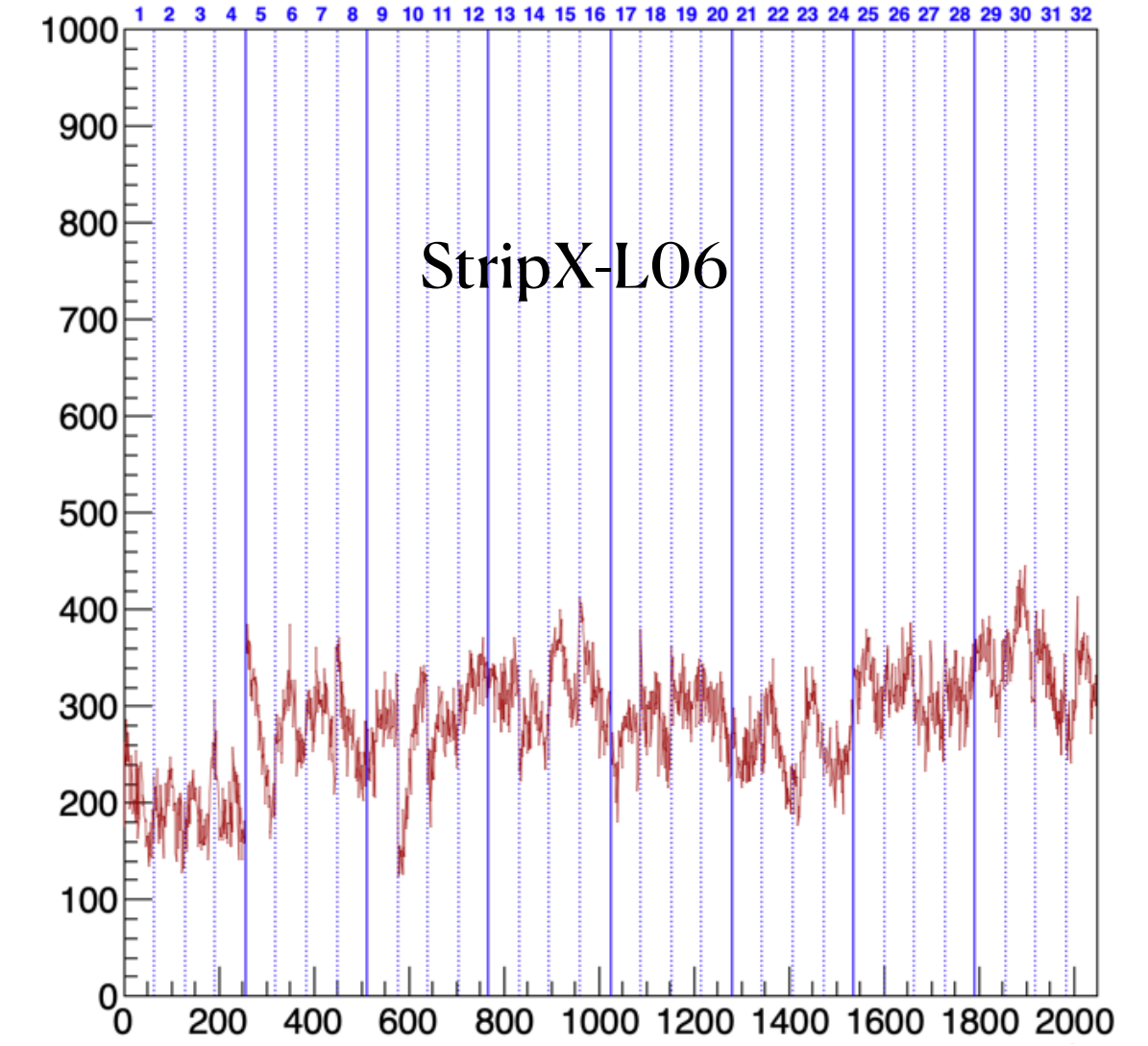
- Pedestals from a calibration run.

- Standard deviation of ADC values per channel from a calibration run (CN subtracted): **~1.5-2.5 ADC units.**

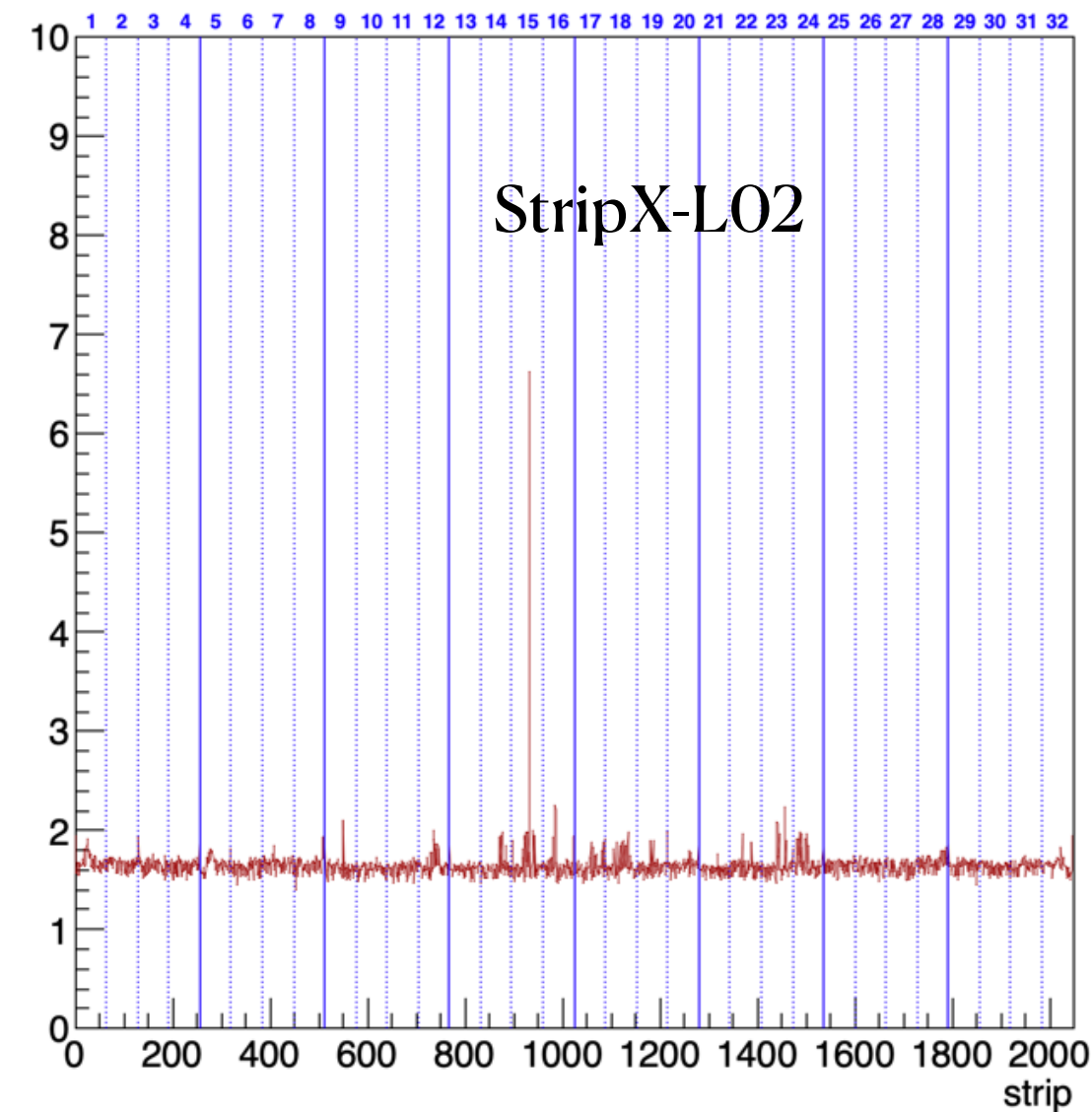
Pedestals - Ladder 0



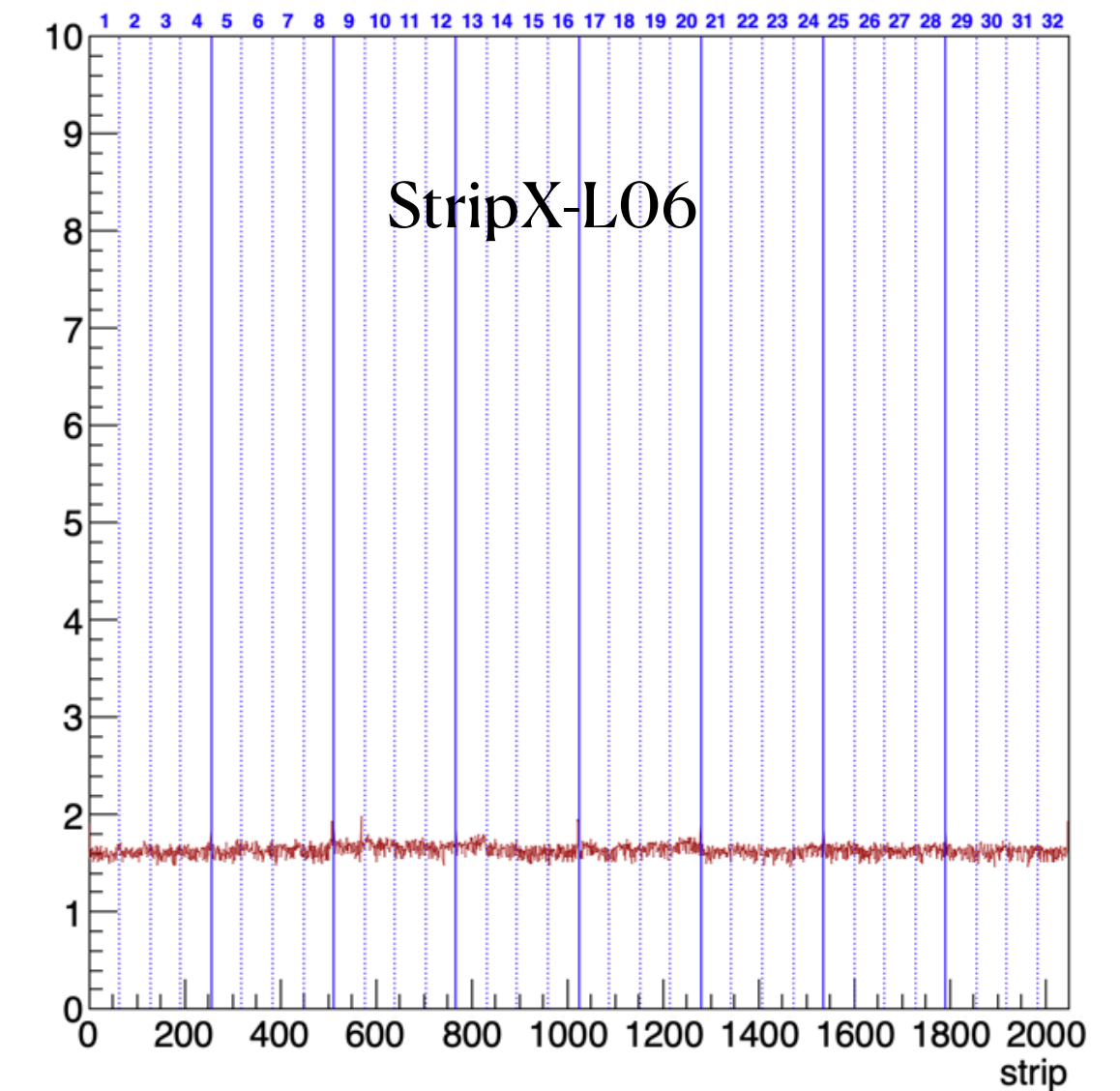
Pedestals - Ladder 1



Sigmas - Ladder 0



Sigmas - Ladder 1

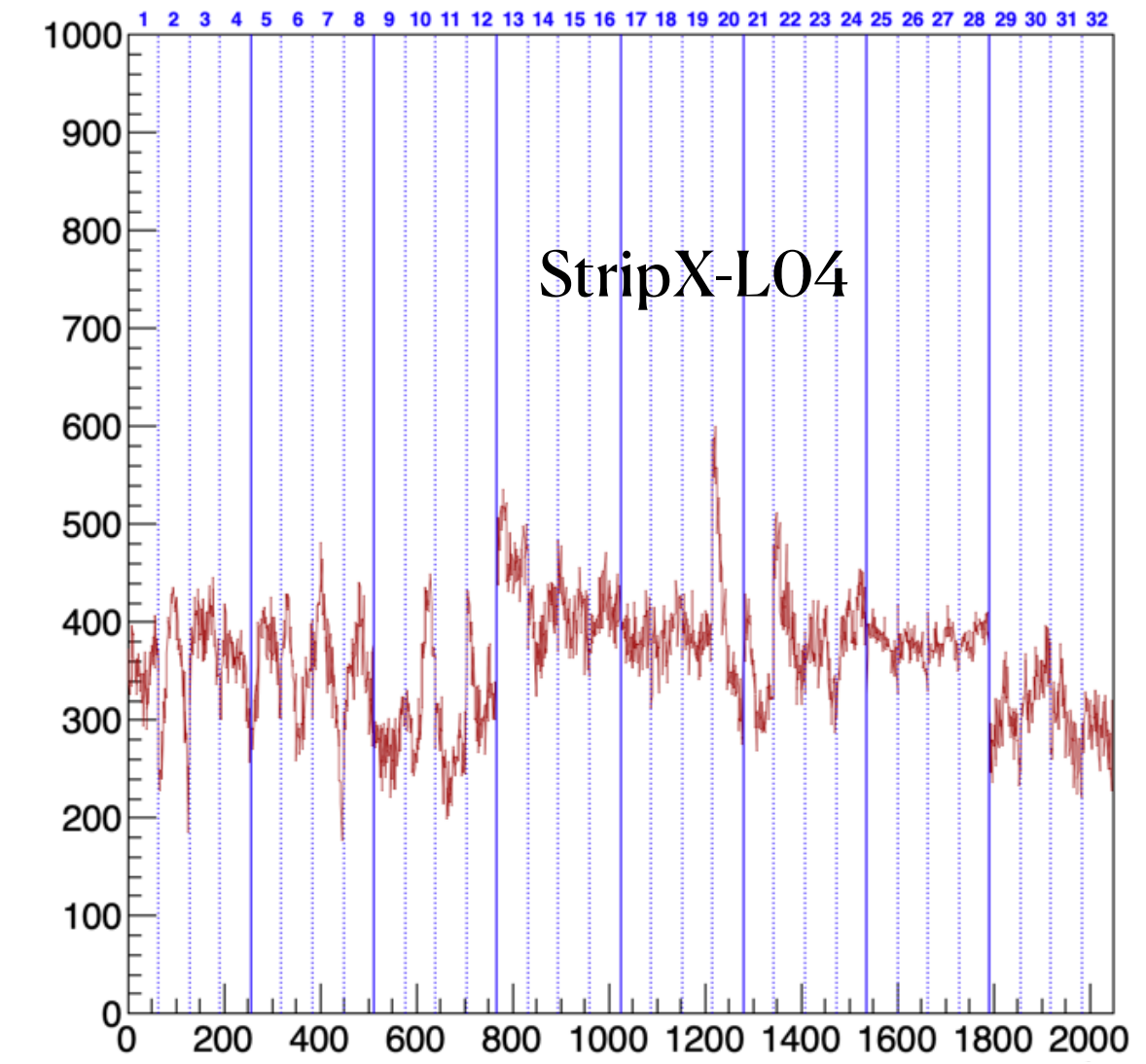


Board 5: StripX-L04 + StripX-L05

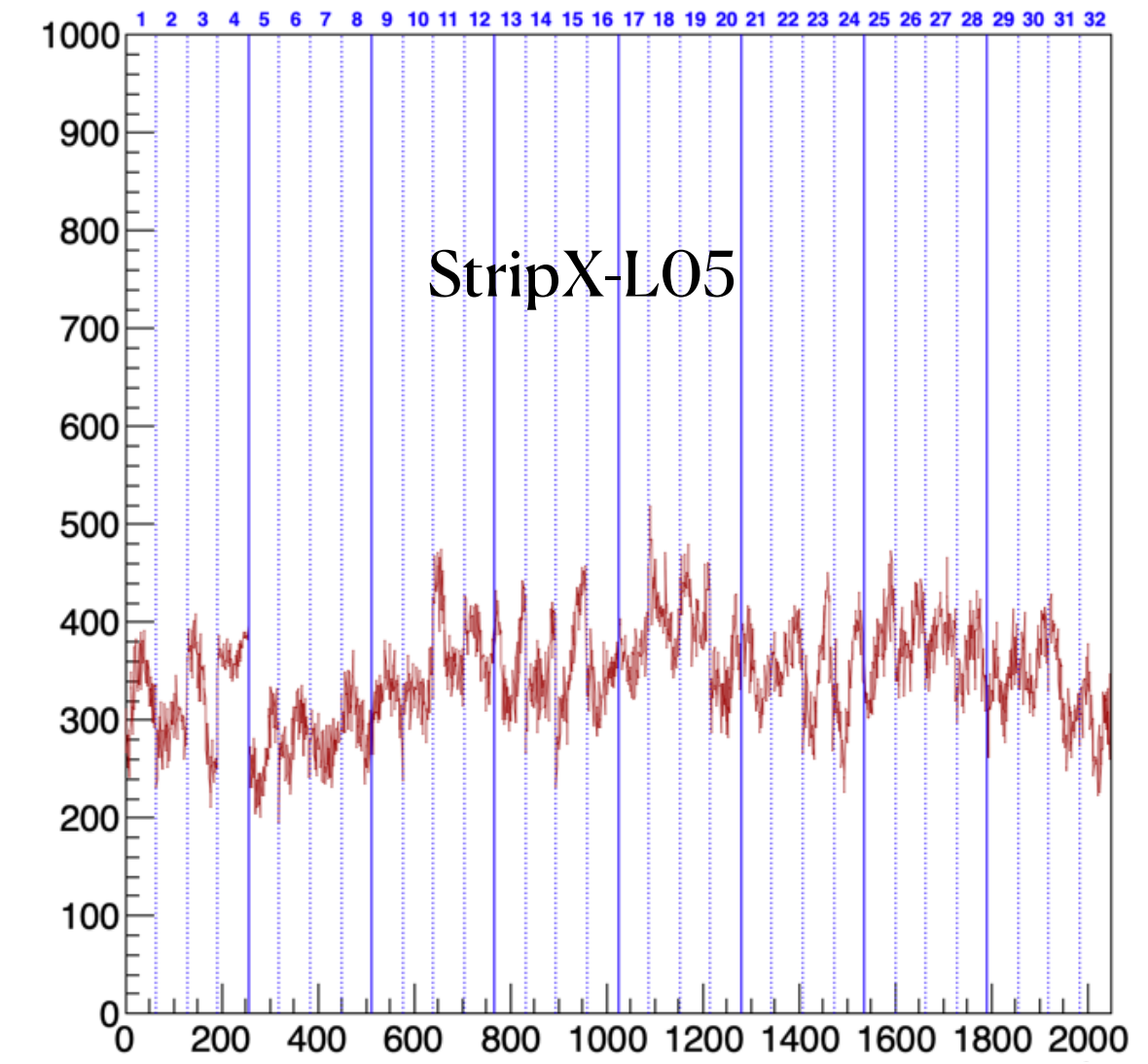
- Pedestals from a calibration run.

- Standard deviation of ADC values per channel from a calibration run (CN subtracted): **~1.5-2.5 ADC units.**

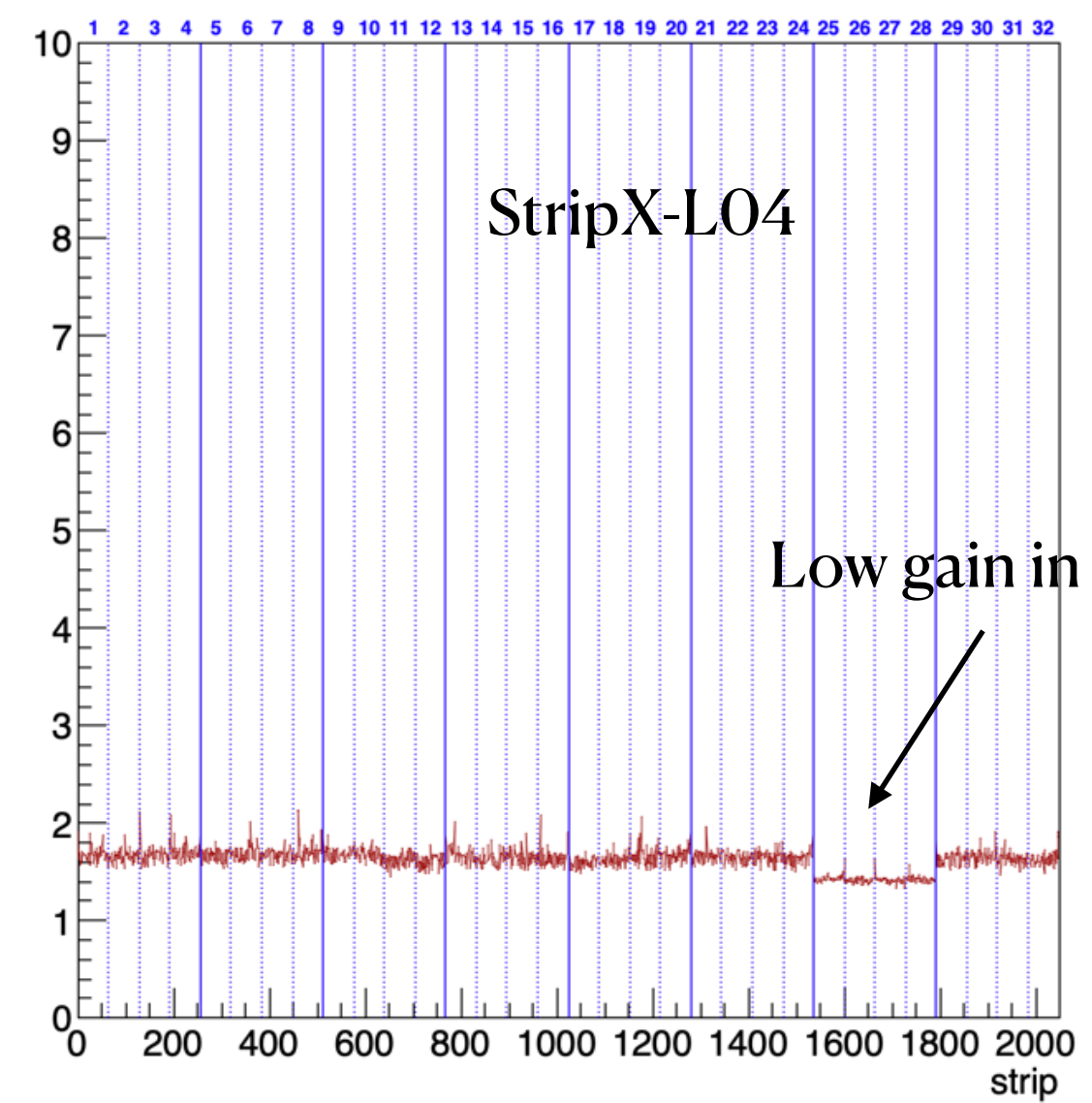
Pedestals - Ladder 0



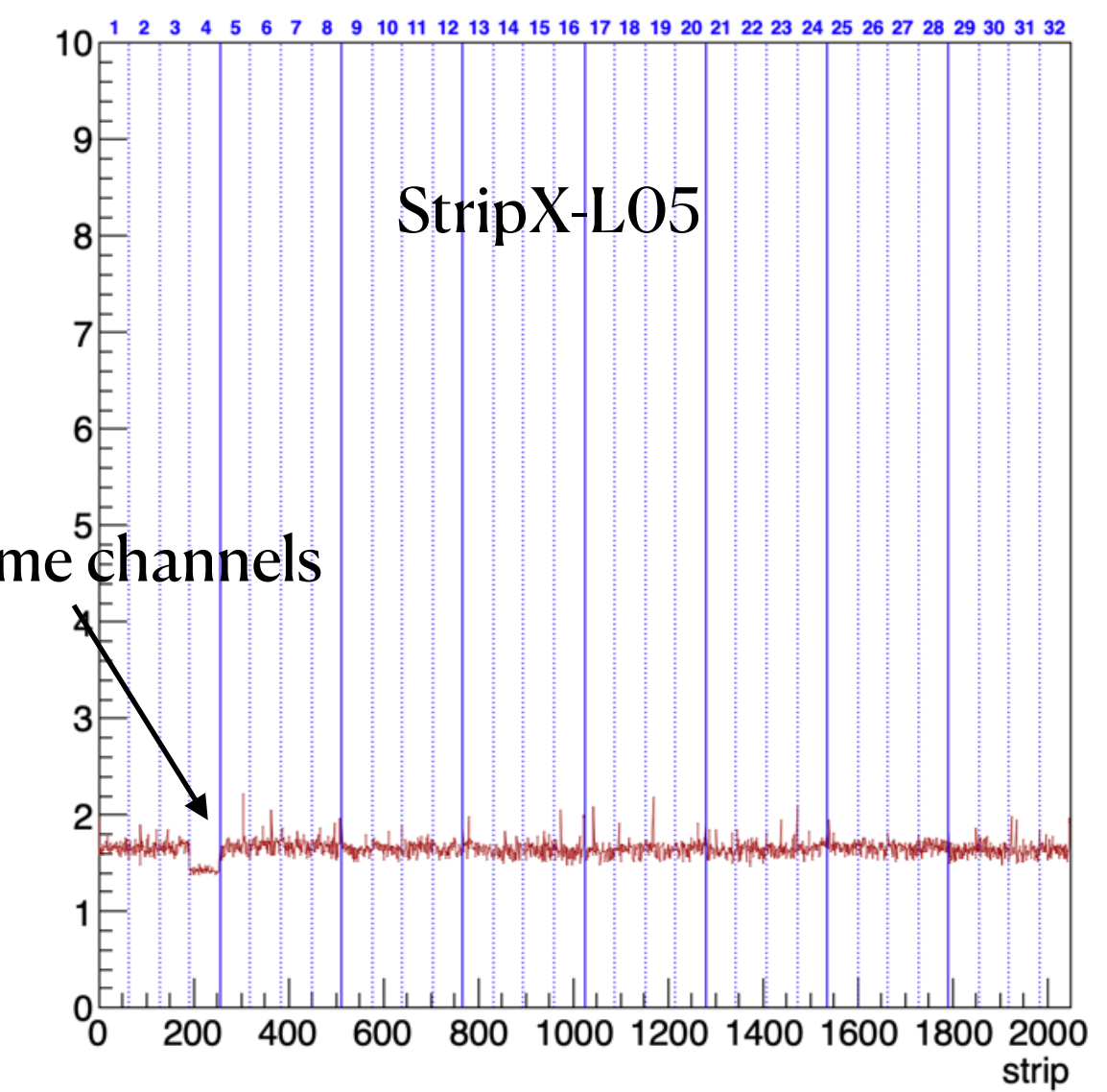
Pedestals - Ladder 1



Sigmas - Ladder 0

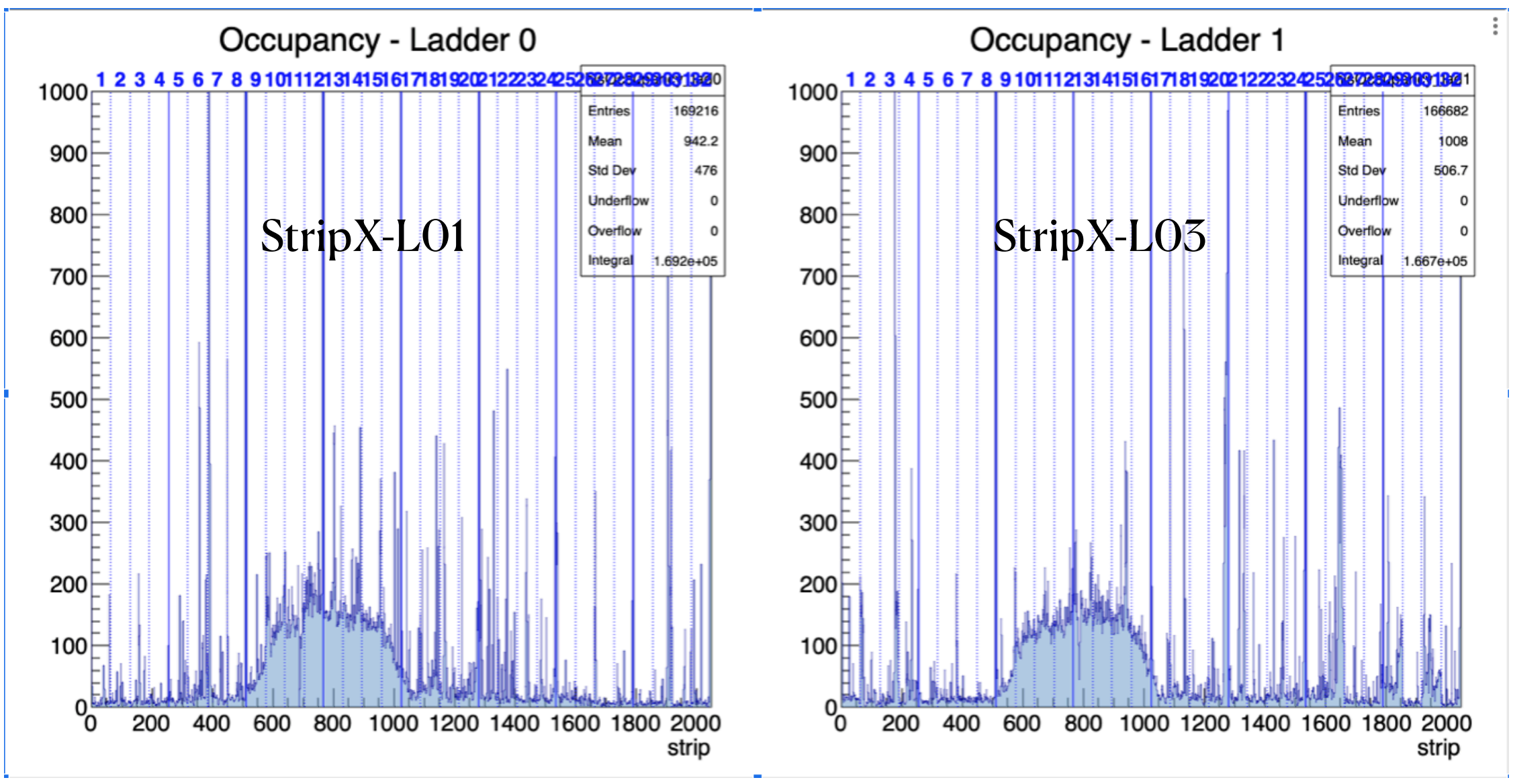


Sigmas - Ladder 1

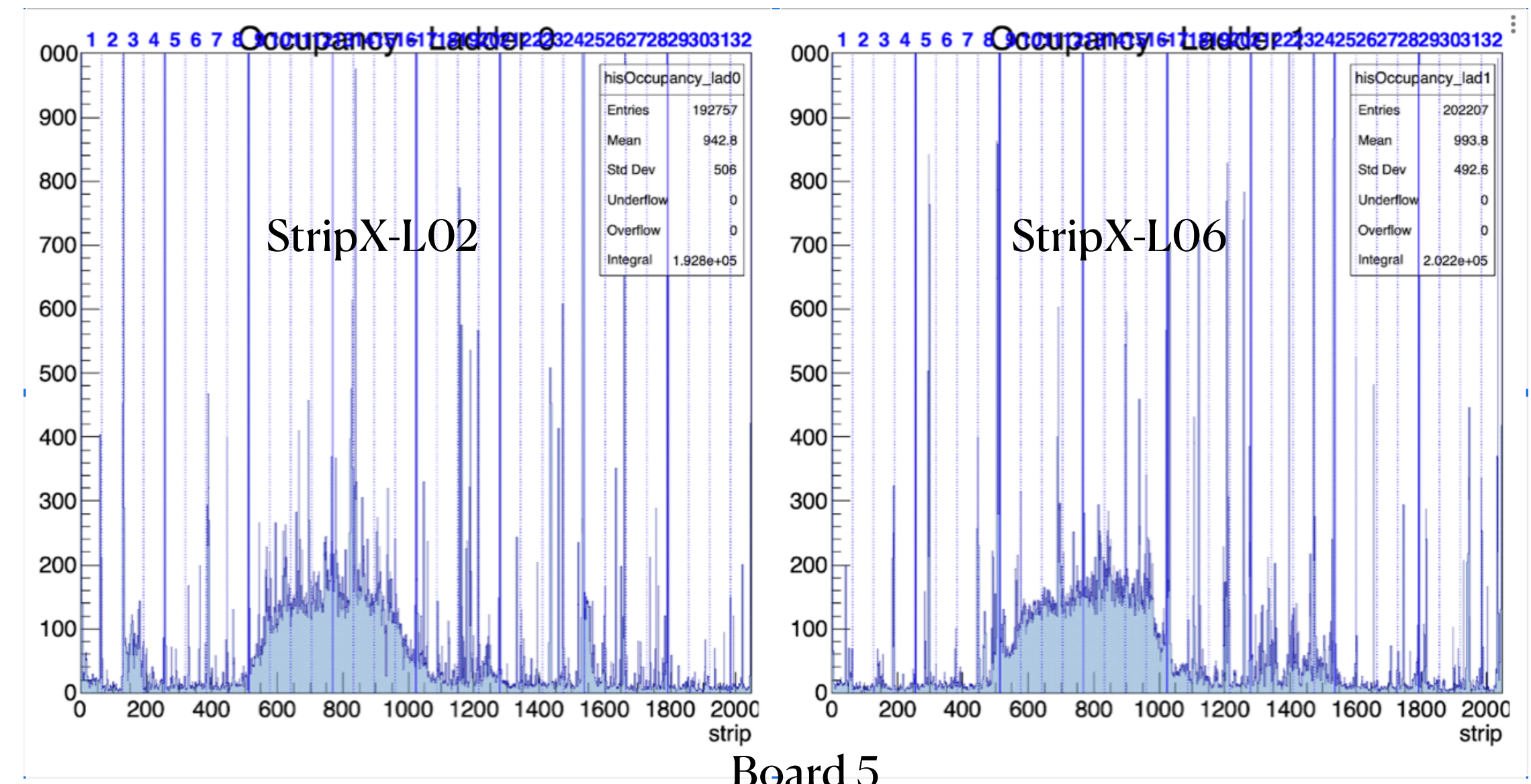


Channel Occupancies with Clusters

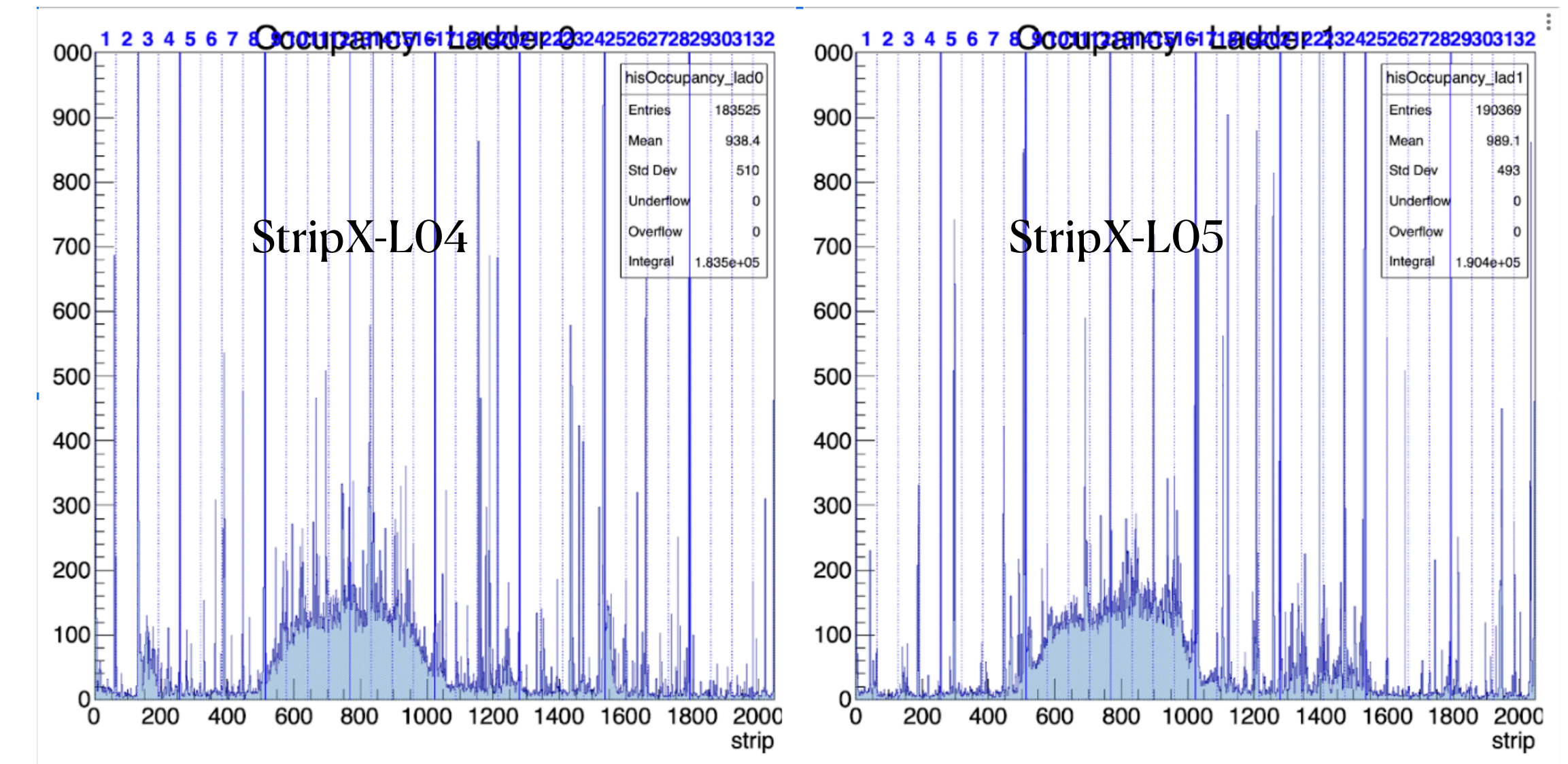
Board 0



Board 3



Board 5



- Clustering algorithm performed with settings:
 - High threshold: **4 SNR** (signal/noise ratio)
 - Low threshold: **1.5 SNR**

Tracks Fitting. Magnets NOT Installed

- Input: a synchronised ROOT file with clusters per event (CoGs, sizes, integrals, SNR distributions)
- Processing:
 - Linear χ^2 fit $Y_{fit} = Slp \cdot Z_{det} + Int_{z=0}$, where Slp - a track slope, $Int_{z=0}$ - an intercept of the track at the layer 0.
 - Only events with **1 cluster** in every layer are fitted.
- Performance metrics: χ^2/NDF , p-value, unbiased residuals per layer, RMS of unbiased residuals per track

Gradient Descent Alignment

- Based on minimisation of a global

$$\chi^2 = \sum_t \sum_p (Y_t^{fit} - Y_{t,p}^{hit})^2 / N_{tracks}$$

- 18 parameters to vary:

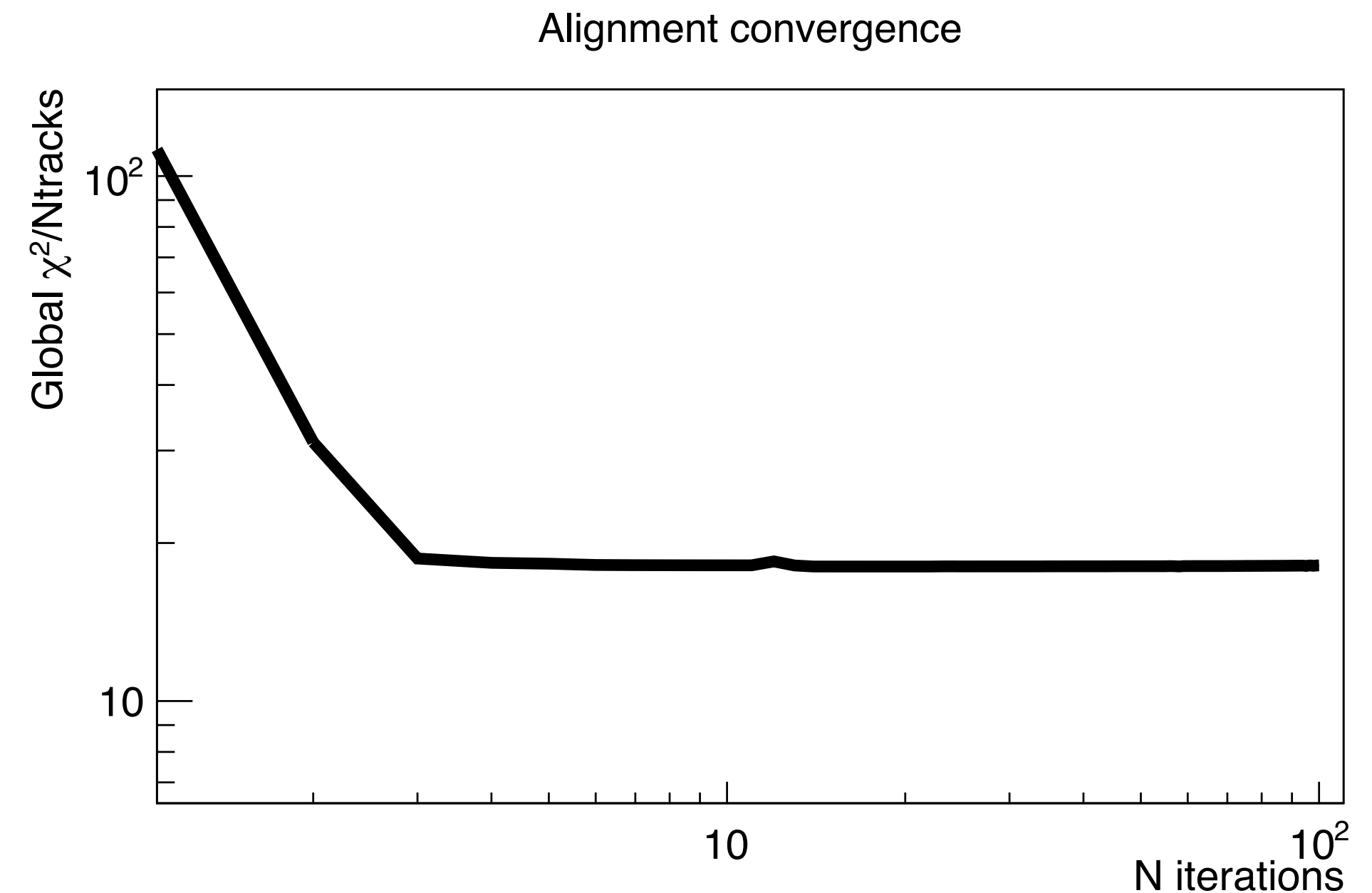
$$Y'_{CoG} = Y_{CoG} + \Delta_{Y,i} - Z_{det} \cdot \theta_{X,i},$$

$$Z'_{det} = Z_{det} + \Delta_{Z,i} + Y_{CoG} \cdot \theta_{X,i}$$

- $\Delta_{Y,i}$, $\Delta_{Z,i}$, $\theta_{X,i}$ - shifts and a tilt around X of the i -th layer

- Perform gradient descent for N iterations:

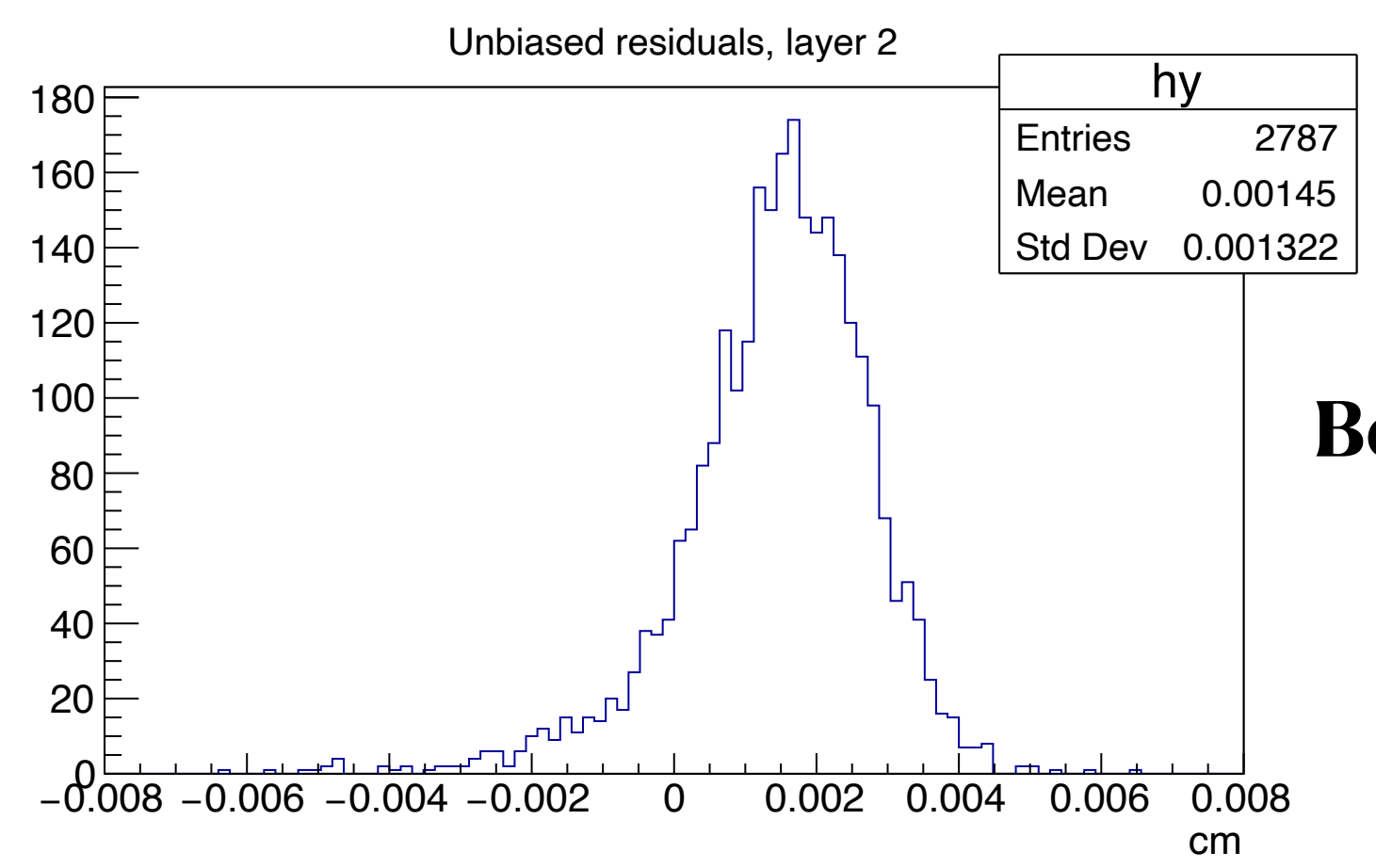
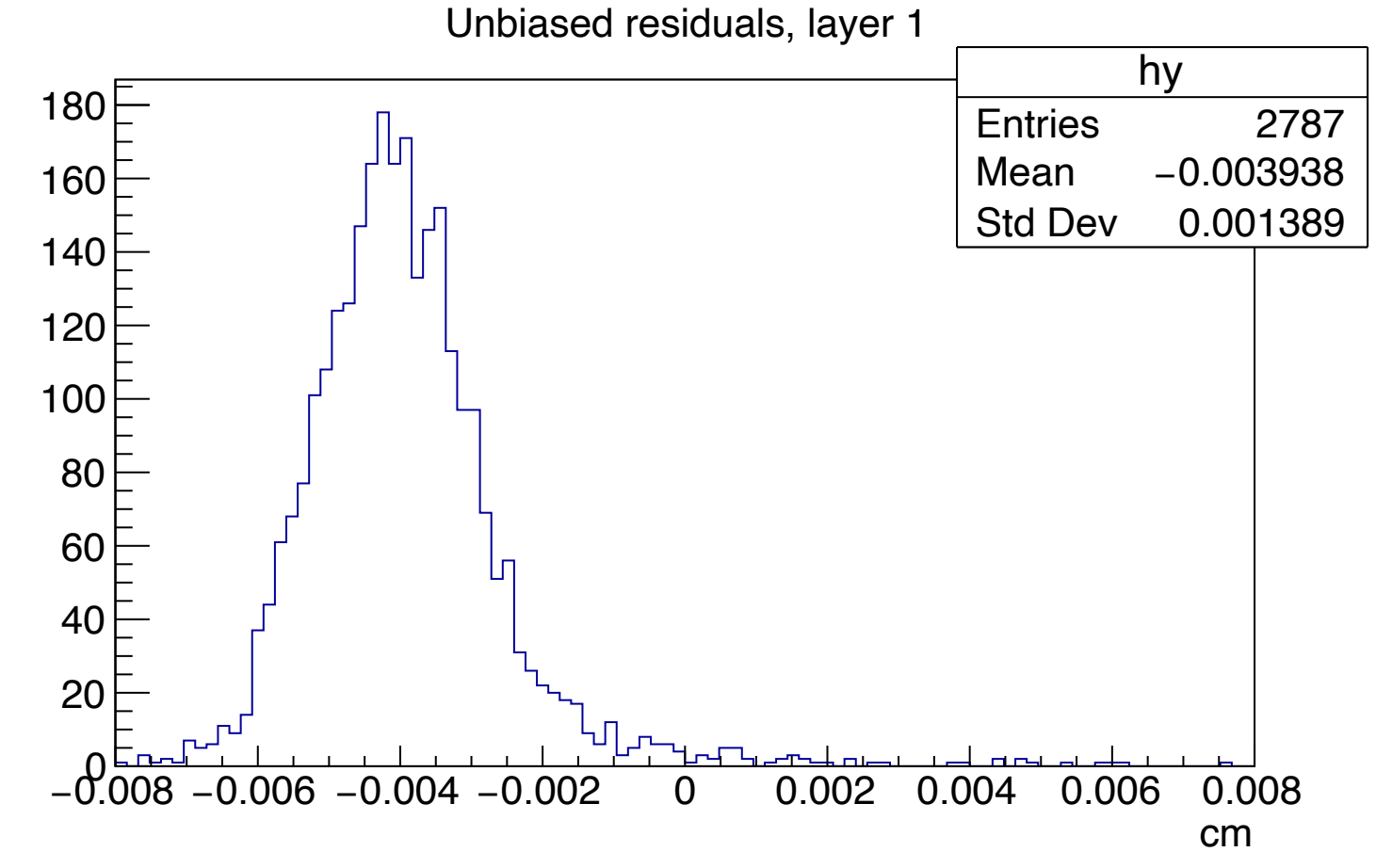
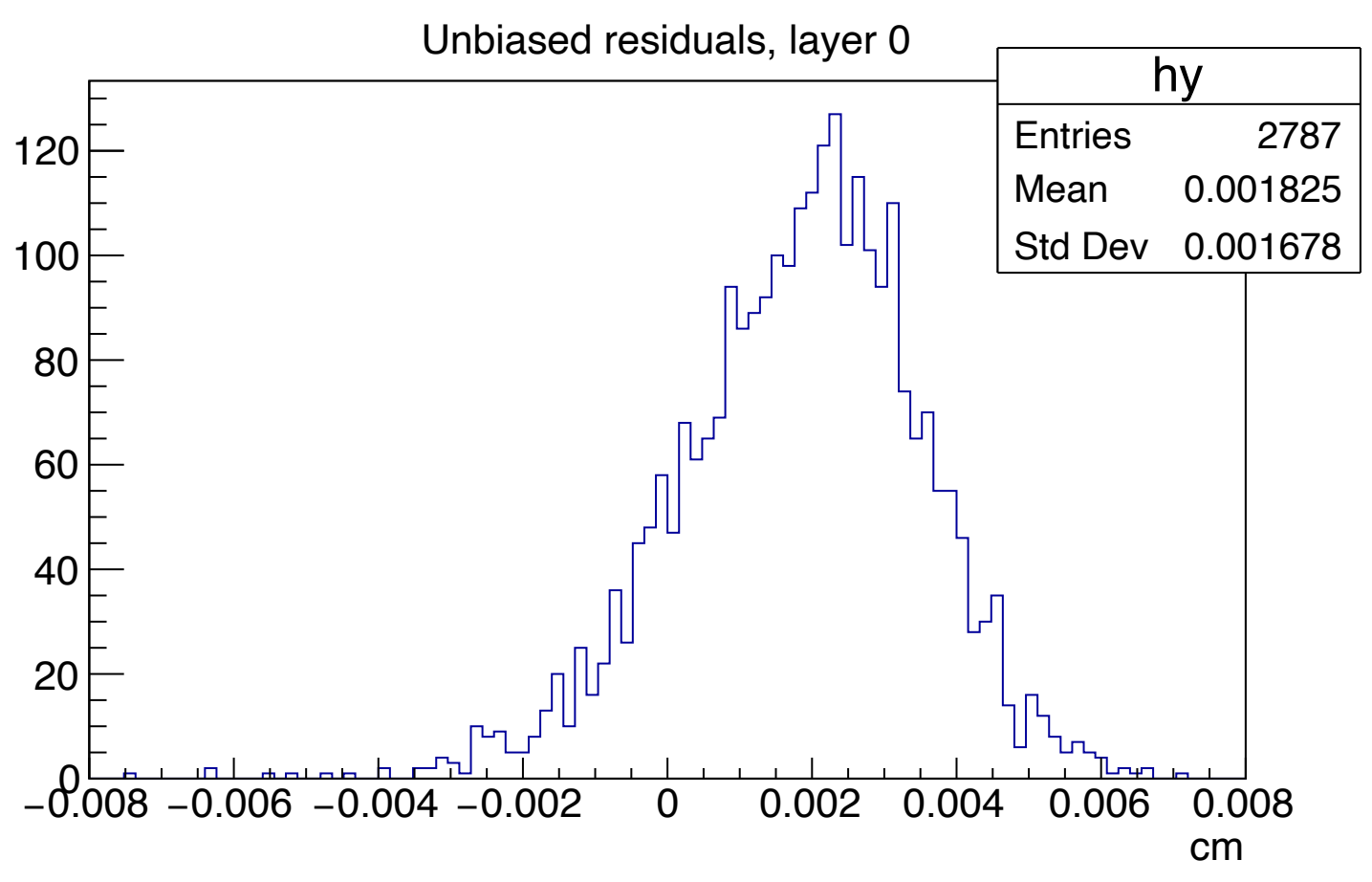
$$\vec{x}_N = \vec{x}_{N-1} - \gamma_{N-1} \nabla \chi^2(\vec{x}_{N-1}), \vec{x}_N - \text{vector of parameters, } \gamma_{N-1} - \text{step size}$$



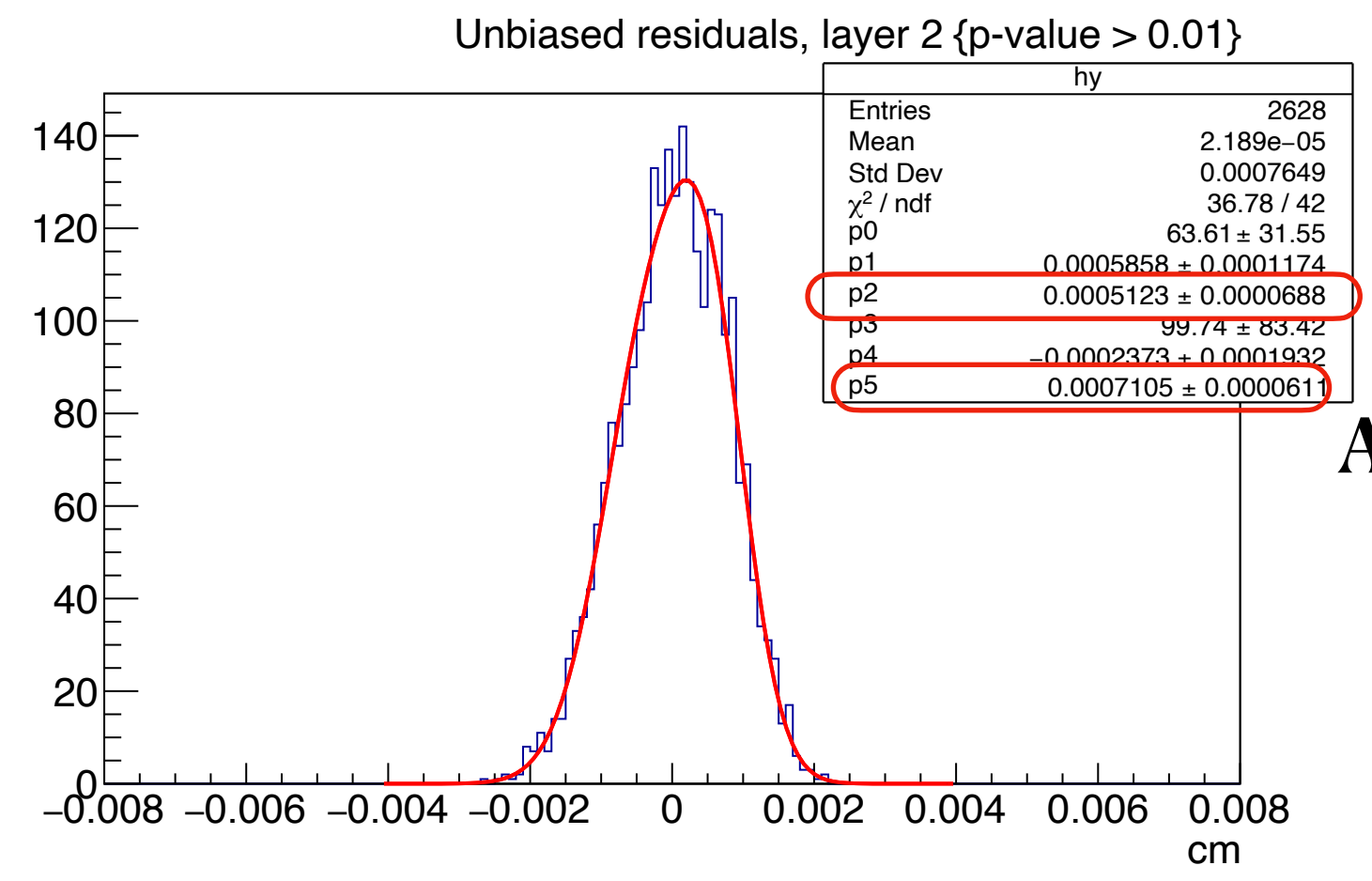
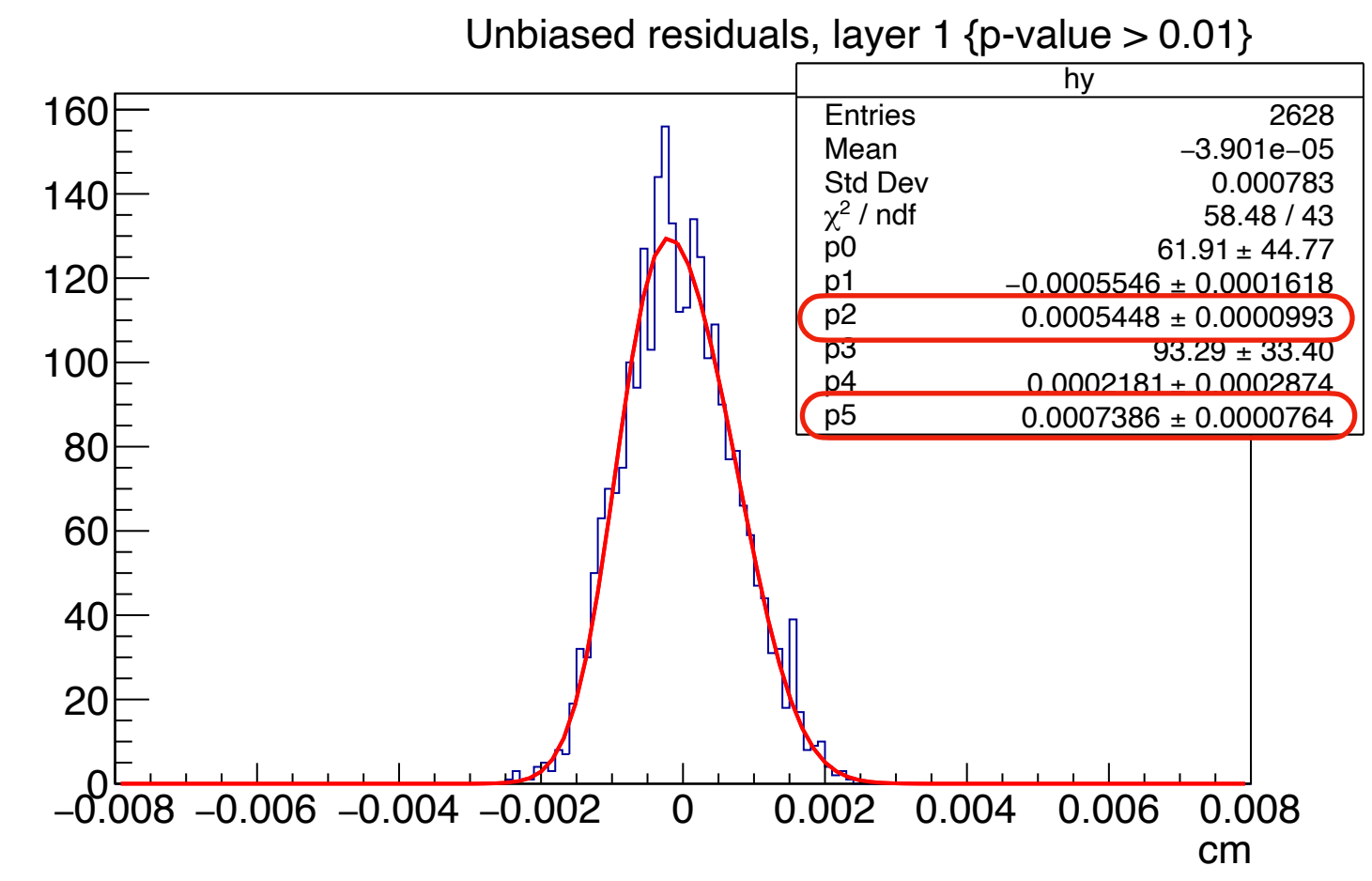
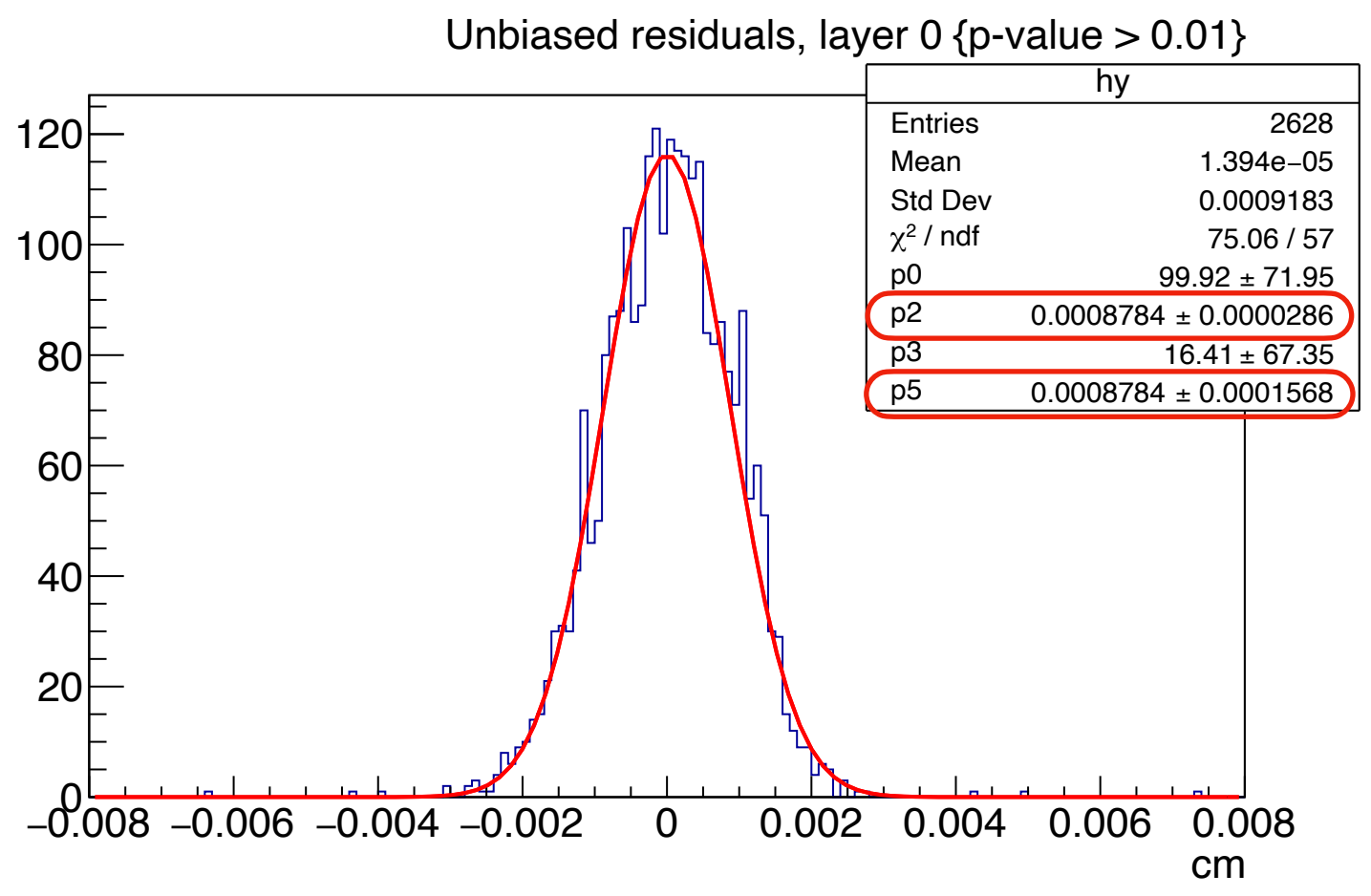
Converges after ~100 iterations!

Unbiased residuals. Layers 0, 1, 2

$$\text{residual} = Y_{fit} - Y_{CoG}, \sigma_{12} = \sqrt{f \cdot \sigma_1^2 + (1 - f) \cdot \sigma_2^2}$$



Before alignment



After alignment

$$\sigma_0 = 8.78 \pm 0.29 \mu\text{m}$$

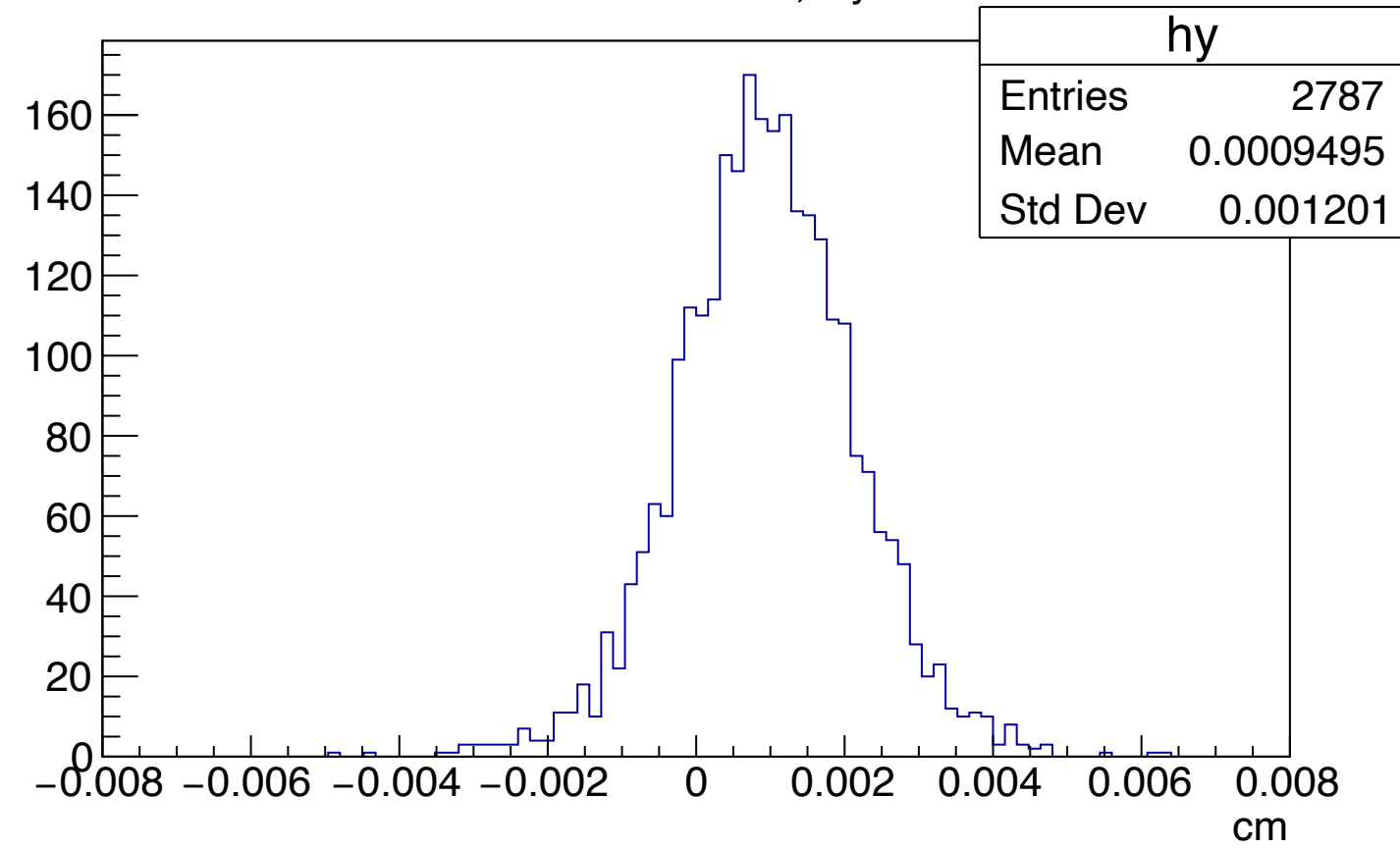
$$\sigma_1 = 6.68 \pm 0.86 \mu\text{m}$$

$$\sigma_2 = 6.40 \pm 0.64 \mu\text{m}$$

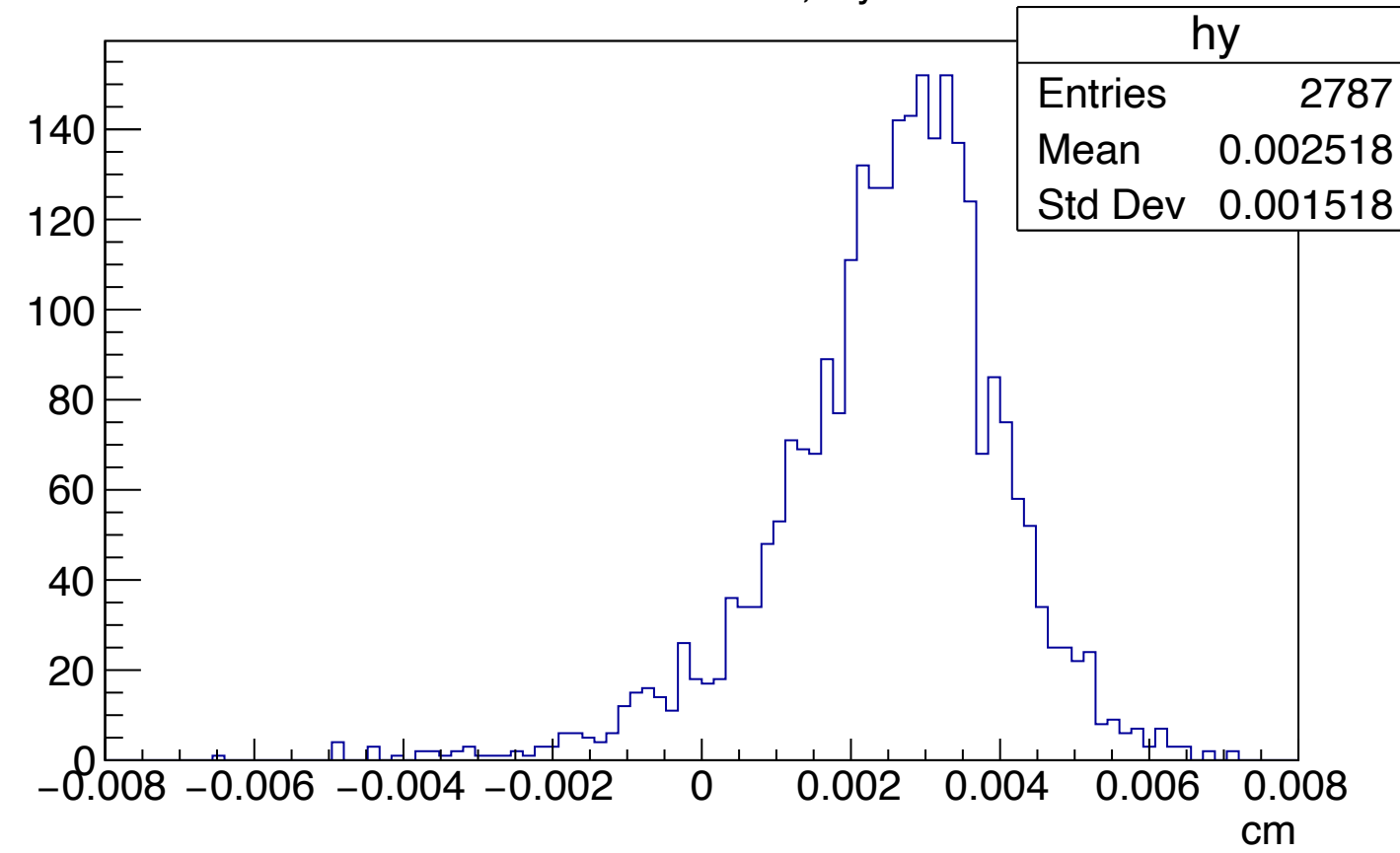
Unbiased residuals. Layers 3, 4, 5

$$\text{residual} = Y_{fit} - Y_{CoG}, \sigma_{12} = \sqrt{f \cdot \sigma_1^2 + (1 - f) \cdot \sigma_2^2}$$

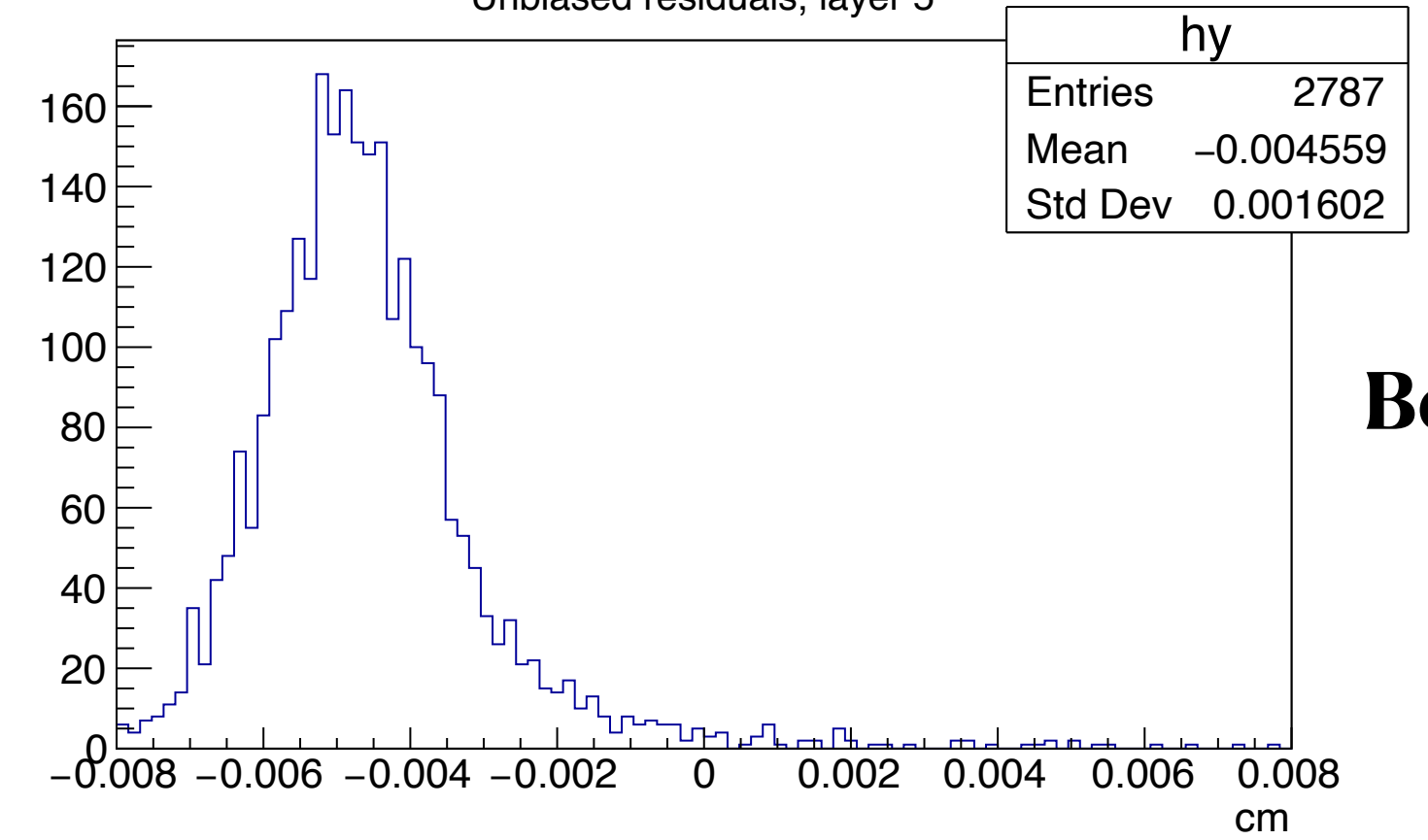
Unbiased residuals, layer 3



Unbiased residuals, layer 4

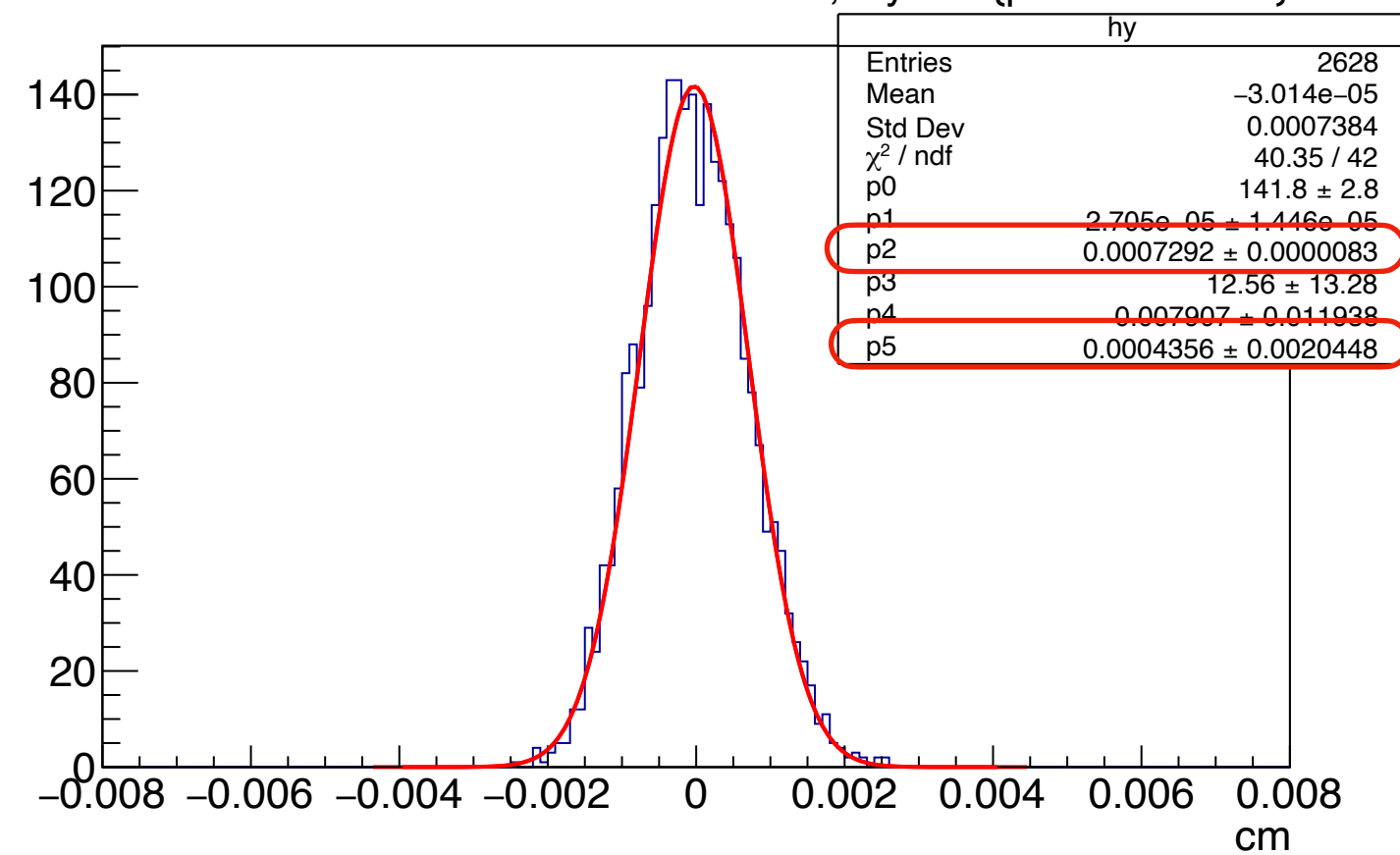


Unbiased residuals, layer 5

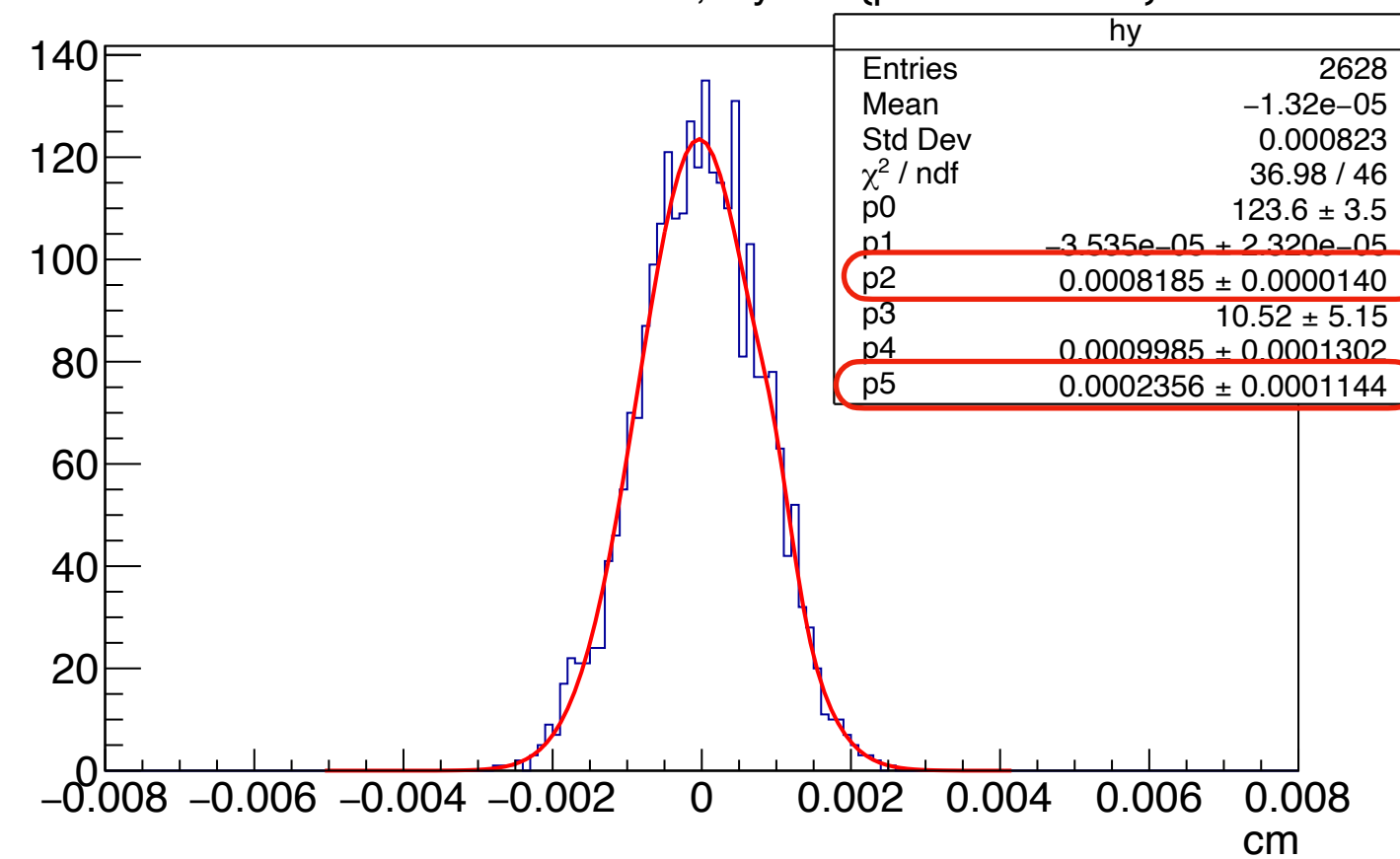


Before alignment

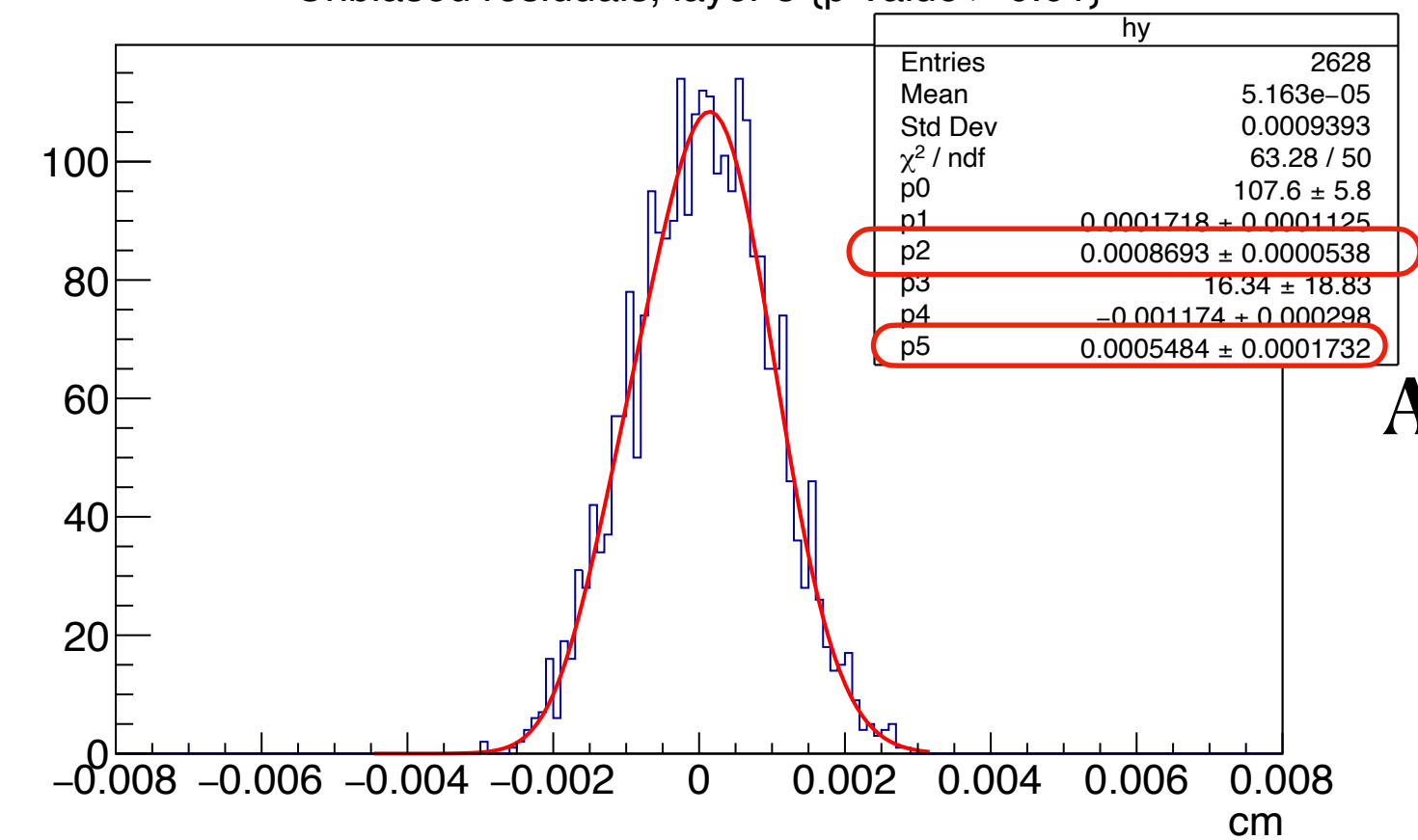
Unbiased residuals, layer 3 {p-value > 0.01}



Unbiased residuals, layer 4 {p-value > 0.01}



Unbiased residuals, layer 5 {p-value > 0.01}



After alignment

$$\sigma_3 = 6.86 \pm 0.63 \mu\text{m}$$

$$\sigma_4 = 7.89 \pm 0.34 \mu\text{m}$$

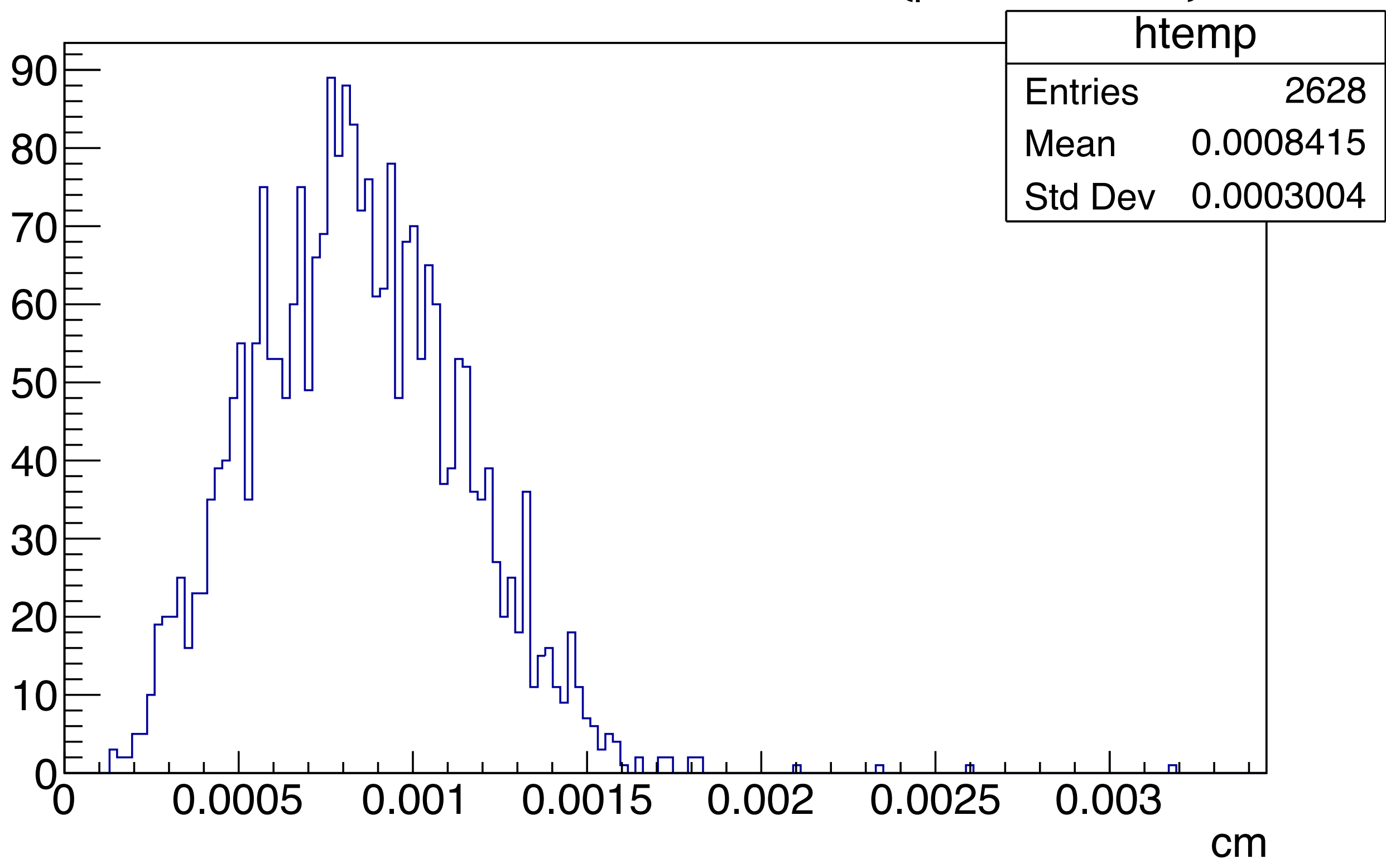
$$\sigma_5 = 8.34 \pm 0.81 \mu\text{m}$$

RMS of Unbiased Residuals per Track

After alignment

Alignment parameters

Standard dev. of unbiased residuals {p-value > 0.01}



Mean = $8.42 \pm 0.06 \mu\text{m}$

Layer: 0

$\Delta_{Y,0}$: 0.026 μm
 $\Delta_{Z,0}$: -0.014 μm
 $\theta_{X,0}$: 2.773e-05

Layer: 1

$\Delta_{Y,1}$: -0.433 μm
 $\Delta_{Z,1}$: 0.016 μm
 $\theta_{X,1}$: -3.944e-04

Layer: 2

$\Delta_{Y,2}$: 2.56902 μm
 $\Delta_{Z,2}$: 2.950e-04 μm
 $\theta_{X,2}$: 2.346e-04

Layer: 3

$\Delta_{Y,3}$: -1.4312 μm
 $\Delta_{Z,3}$: 3.301e-03 μm
 $\theta_{X,3}$: 1.313e-04

Layer: 4

$\Delta_{Y,4}$: 0.012 μm
 $\Delta_{Z,4}$: -0.008 μm
 $\theta_{X,4}$: -1.716e-05

Layer: 5

$\Delta_{Y,5}$: -0.394 μm
 $\Delta_{Z,5}$: 2.869e-03 μm
 $\theta_{X,5}$: 4.306e-04

Layer: 0 - upstream

Layer: 5 - downstream

Better Errors and MCS Contribution

- Corrected measurement errors:

- If cluster size == 1:

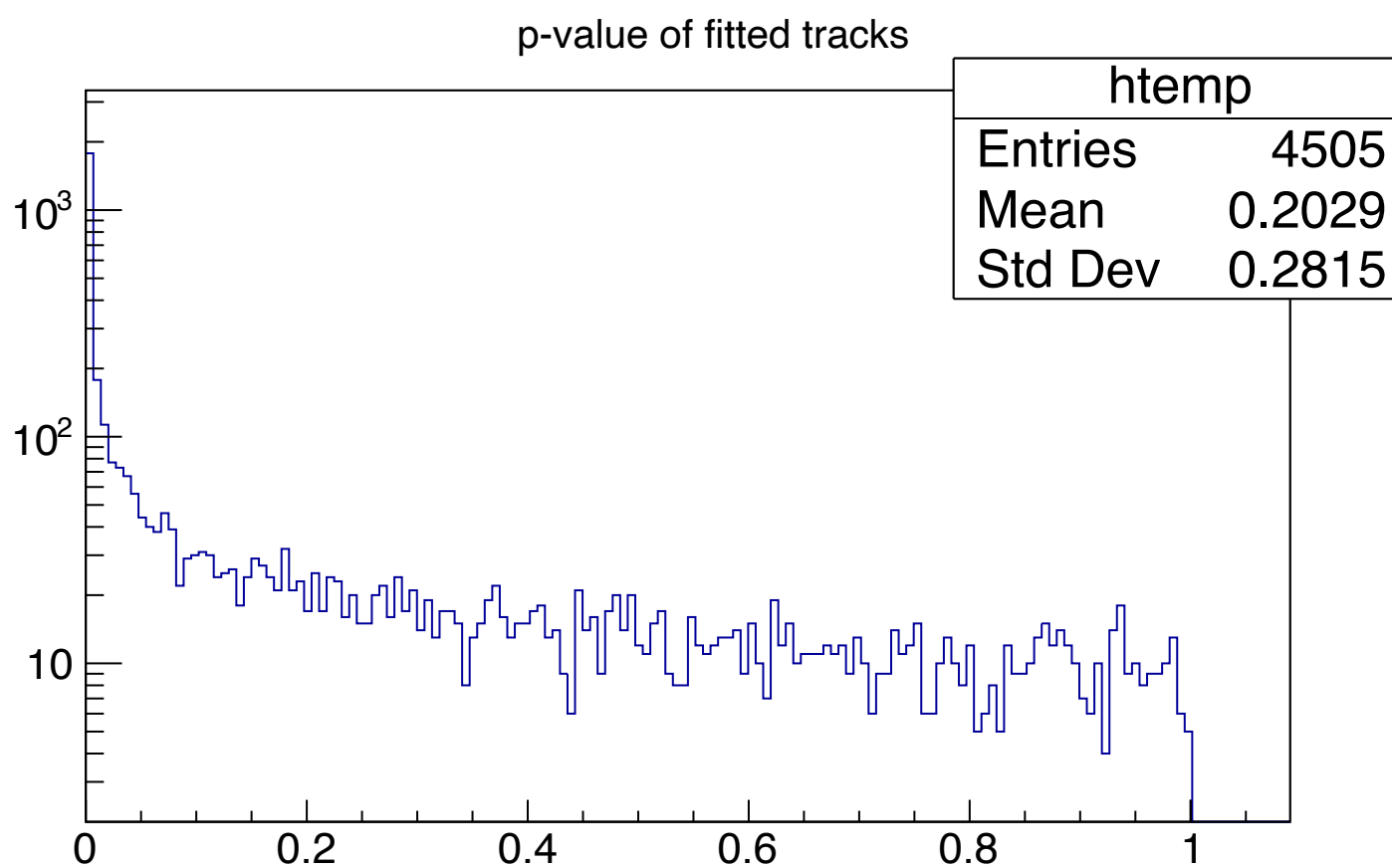
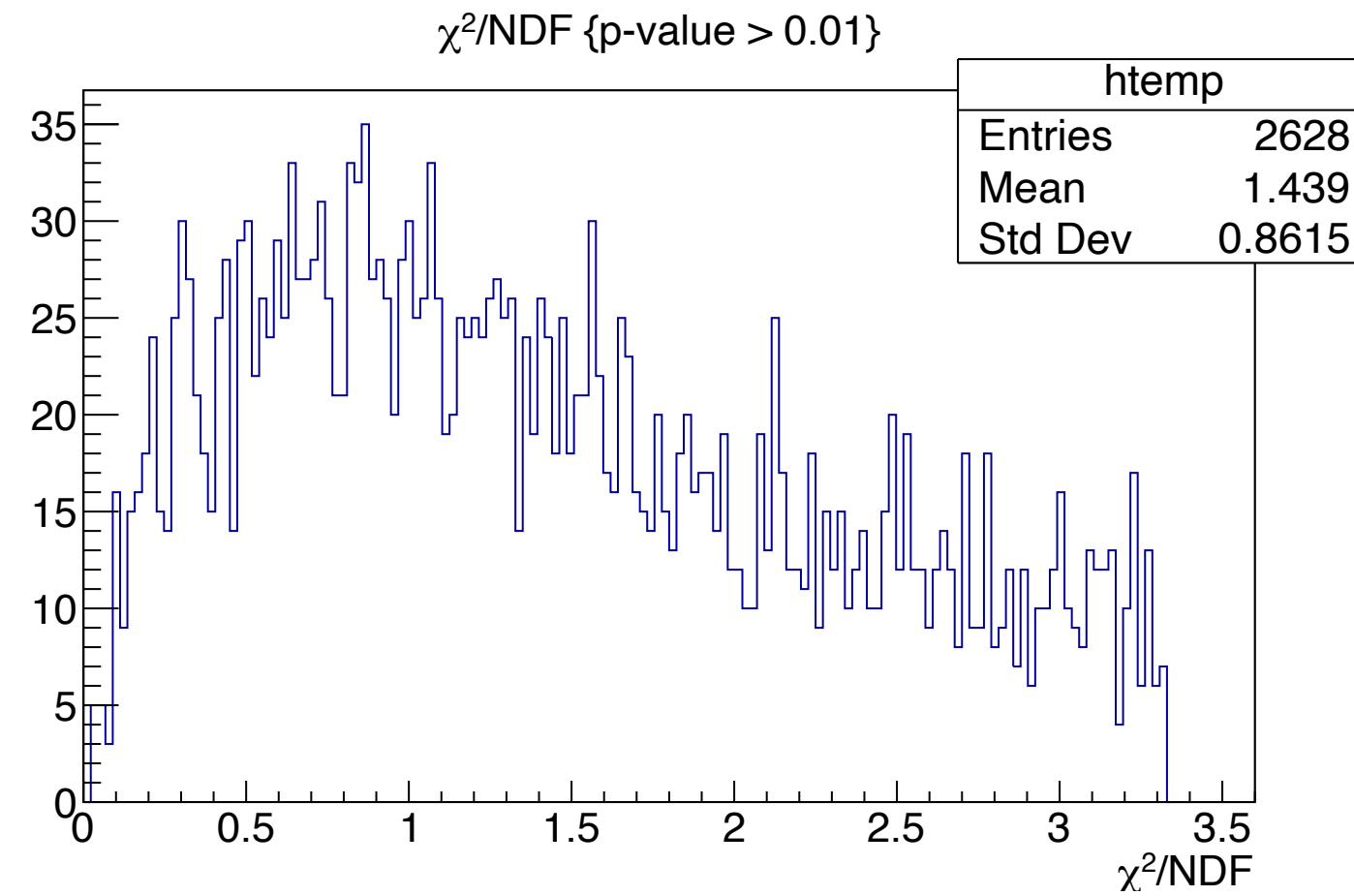
$$\sigma_Y = p/\sqrt{12}$$

- Else: $\sigma_Y = \alpha \cdot p/\text{SNR}$

- SNR - signal/noise averaged over the cluster

- $\alpha \lesssim \sqrt{1.5 + \text{clustSize}}$ ¹

After alignment



Scattering angle:

$$\theta_0 = \frac{13.6\text{MeV}}{p\beta c} z_c \sqrt{\frac{x_{det}}{X_{Si}}} \left[1 + 0.038 \ln \left(\frac{x_{det}}{X_{Si}} \right) \right]$$

MCS contribution per layer for 10 GeV/c pions
 $\sigma_{MCS}, \mu\text{m}$

Layer 0:	0
Layer 1:	0.75
Layer 2:	5.30
Layer 3:	6.41
Layer 4:	12.30
Layer 5:	13.74

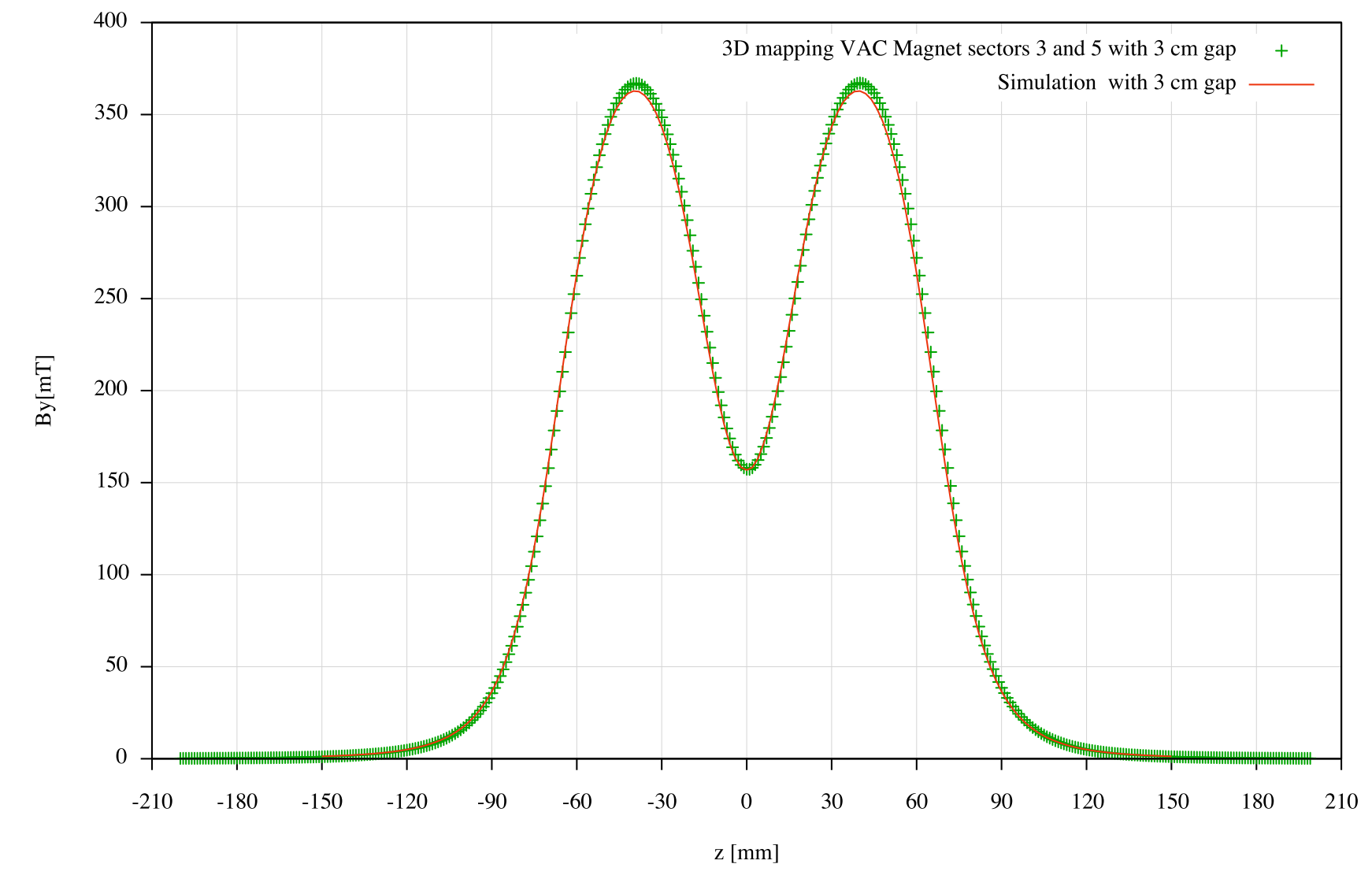
P-values are ≈ flat.

$$\chi^2/NDF \rightarrow 1$$

¹ : V . Radeka and R .A . Boie, Nucl . Instr. and Meth . 178 (1980) 543

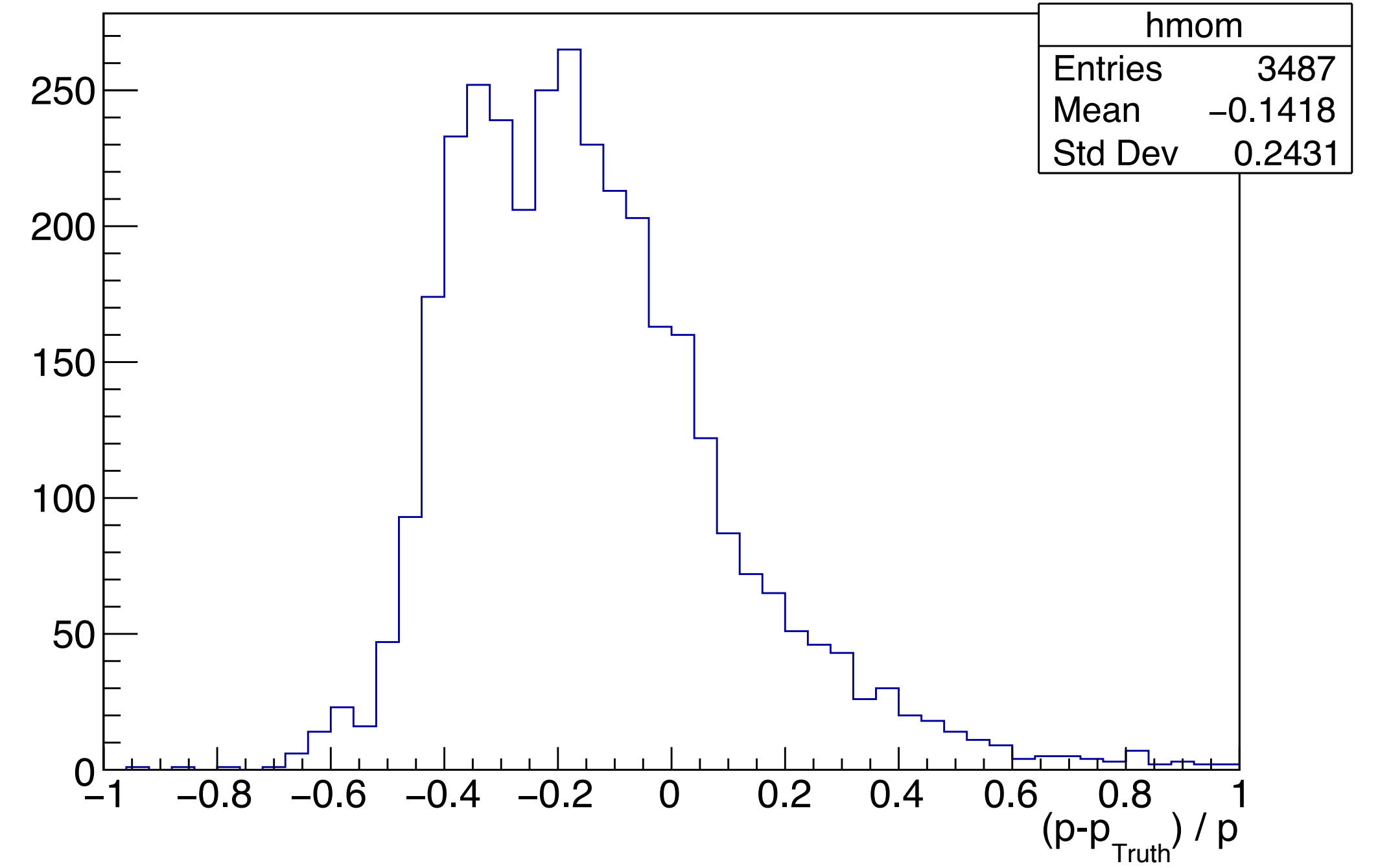
Tracks Reconstruction Modifications

- Implementation of a **realistic** magnetic field map
- Adding **Kalman filter** based on GENFIT package for tracks fitting



Magnetic field map used for tracks reconstruction

Reconstructed momentum error (p-value > 0.01)



Preliminary (!) results of the momentum resolution for 10 GeV/c π^- .
The tracks displacement due to bending is of the order of a few channels on the last station

Conclusion and Next steps

- **6 StripX layers** are working together producing meaningful data.
- Minimum sigma of the coordinate residuals: $6.40 \pm 0.64 \mu\text{m}$ for a middle layer
- Curved tracks reconstructed for beam test data. ~24 % momentum resolution achieved (preliminary!)

-
- Continue data taking using cosmic rays in our lab.
 - Add StripY and ToF detectors to the current prototype.
 - Prepare for the next beamtests in 2022.